

# HT32F61641 Datasheet

32-Bit Arm® Cortex®-M0+ Li-Battery Protection Microcontroller, up to 64 KB Flash and 8 KB SRAM with 1 Msps ADC, DIV, USART, UART, SPI, I<sup>2</sup>C, MCTM, GPTM, BFTM, PWM, CRC, RTC and WDT

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# **1** General Description

The Holtek HT32F61641 device is a high performance, low power consumption 32-bit microcontroller based around an Arm<sup>®</sup> Cortex<sup>®</sup>-M0+ processor core. The Cortex<sup>®</sup>-M0+ is a next-generation processor core which is tightly coupled with Nested Vectored Interrupt Controller (NVIC), SysTick timer, and including advanced debug support.

The device operates at a frequency of up to 20 MHz to obtain maximum efficiency. It provides up to 64 KB of embedded Flash memory for code/data storage and 8 KB of embedded SRAM memory for system operation and application program usage. A variety of peripherals, such as Hardware Divider DIV, ADC, I<sup>2</sup>C, USART, UART, SPI, MCTM, GPTM, PWM, BFTM, CRC-16/32, RTC, WDT, SW-DP (Serial Wire Debug Port), etc., are also implemented in the device. Several power saving modes provide the flexibility for maximum optimization between wakeup latency and power consumption, an especially important consideration in low power applications.

The device also includes an accumulative cell voltage monitor, a high accuracy voltage regulator, two discharge N-type MOSFET gate-drivers and a charge N-type MOSFET gate-driver which are provided for 3 to 8 cell Li-ion rechargeable battery applications. The accumulative cell voltage monitor is used to monitor an accumulative voltage from 1 to N and output the divide-by-N voltage to the analog multiplexer with a  $\pm 0.5$  % divided ratio accuracy which can then be connected the VOUT pin to the one of the integrated A/D converter channel for measurement. The device can directly drive external power N-type MOSFETs to control charge and discharge by charge and discharge gate-drivers. The integrated battery balance circuitry provides a cell balance current without the need of external transistors.

The above features ensure that the device is suitable for use in a wide range of applications, especially in areas such as handheld instruments, electronically controlled tools, handheld hair dryers, handheld vacuum cleaners and other handheld devices.





# **2** Features

#### Core

- 32-bit Arm® Cortex®-M0+ processor core
- Up to 20 MHz operating frequency
- Single-cycle multiplication
- Integrated Nested Vectored Interrupt Controller (NVIC)
- 24-bit SysTick timer

The Cortex®-M0+ processor is a very low gate count, highly energy efficient processor that is intended for microcontroller and deeply embedded applications that require an area optimized, low-power processor. The processor is based on the ARMv6-M architecture and supports Thumb® instruction sets, single-cycle I/O ports, hardware multiplier and low latency interrupt respond time.

### **On-Chip Memory**

- Up to 64 KB on-chip Flash memory for instruction/data and options storage
- Up to 8 KB on-chip SRAM
- Supports multiple boot modes

The Arm® Cortex®-M0+ processor accesses and debug accesses share the single external interface to external AHB peripherals. The processor accesses take priority over debug accesses. The maximum address range of the Cortex®-M0+ is 4 GB since it has a 32-bit bus address width. Additionally, a pre-defined memory map is provided by the Cortex®-M0+ processor to reduce the software complexity of repeated implementation by different device vendors. However, some regions are used by the Arm® Cortex®-M0+ system peripherals. Refer to the Arm® Cortex®-M0+ Technical Reference Manual for more information. Figure 2 in the Overview chapter shows the memory map of the device, including code, SRAM, peripheral and other pre-defined regions.

## Flash Memory Controller - FMC

- 32-bit word programming with In System Programming Interface (ISP) and In Application Programming (IAP)
- Flash protection capability to prevent illegal access

The Flash Memory Controller, FMC, provides all the necessary functions for the embedded onchip Flash Memory. The word program/page erase functions are also provided.

### Reset Control Unit – RSTCU

- Supply supervisor:
  - Power on Reset / Power down Reset POR / PDR
  - Brown-out Detector BOD
  - Programmable Low Voltage Detector LVD

The Reset Control Unit, RSTCU, has three kinds of reset, a power on reset, a system reset and an APB unit reset. The power on reset, known as a cold reset, resets the full system during power up. A system reset resets the processor core and peripheral IP components with the exception of the SW-DP controller. The resets can be triggered by external signals, internal events and the reset generators.



### **Clock Control Unit - CKCU**

- External 4 to 20 MHz crystal oscillator
- External 32.768 kHz crystal oscillator
- Internal 20 MHz RC oscillator trimmed to ±2 % accuracy at 25 °C operating temperature
- Internal 32 kHz RC oscillator
- Independent clock divider and gating bits for peripheral clock sources

The Clock Control Unit, CKCU, provides a range of oscillator and clock functions. These include a High Speed Internal RC oscillator (HSI), a High Speed External crystal oscillator (HSE), a Low Speed Internal RC oscillator (LSI), a Low Speed External crystal oscillator (LSE), an HSE clock monitor, clock pre-scalers, clock multiplexers, APB clock divider and gating circuitry. The AHB, APB and Cortex®-M0+ clocks are derived from the system clock (CK\_SYS) which can come from the HSI, HSE, LSI or LSE. The Watchdog Timer and Real-Time Clock (RTC) use either the LSI or LSE as their clock source.

### Power Management Control Unit – PWRCU

- Flexible power supply:  $V_{DD}$  power supply (2.5 V ~ 5.5 V),  $V_{DDIO}$  for I/Os (1.8 V ~ 5.5 V)
- Integrated 1.5 V LDO regulator for MCU core, peripherals and memories power supply
- $\blacksquare$  V<sub>DD</sub>, V<sub>DDIO</sub> and V<sub>CORE</sub> power domains
- Three power saving modes: Sleep, Deep-Sleep1, Deep-Sleep2

Power consumption can be regarded as one of the most important issues for many embedded system applications. Accordingly the Power Control Unit, PWRCU, in the device provides many types of power saving modes such as Sleep, Deep-Sleep1 and Deep-Sleep2 mode. These operating modes reduce the power consumption and allow the application to achieve the best trade-off between the conflicting demands of CPU operating time, speed and power consumption.

## **Accumulative Cell Voltage Monitor**

- Accumulative Cell Voltage Monitor 8-to-1 Analog Multiplexer with divided ratio accuracy:  $(1/n \pm 0.5 \%)$
- Cell Charging Balance Switches
- Two Discharge N-type MOSFET Gate-Drivers
- Single Charge N-type MOSFET Gate-Driver
- Sleep Mode with 0.1 μA ultra-low standby current
- Direct High Voltage Wake-up function

### Real-Time Clock – RTC

- 24-bit up-counter with a programmable prescaler
- Alarm function
- Interrupt and Wake-up event

The Real-Time Clock, RTC, includes an APB interface, a 24-bit count-up counter, a control register, a prescaler, a compare register and a status register. The RTC circuits are located in the  $V_{\text{CORE}}$  power domain. When the device enters the power-saving mode, the RTC counter is used as a wakeup timer to generate a system resume or interrupt signal from the MCU power saving mode.



### **External Interrupt/Event Controller – EXTI**

- Up to 13 EXTI lines with configurable trigger source and type
- All GPIO pins can be selected as EXTI trigger source
- Source trigger type includes high level, low level, negative edge, positive edge, or both edges
- Individual interrupt enable, wakeup enable and status bits for each EXTI line
- Software interrupt trigger mode for each EXTI line
- Integrated deglitch filter for short pulse blocking

The External Interrupt/Event Controller, EXTI, comprises 13 edge detectors which can generate a wake-up event or interrupt requests independently. Each EXTI line can also be masked independently.

### Hardware Divider - DIV

- Signed/unsigned 32-bit divider
- Operation in 8 clock cycles, load in 1 clock cycle
- Divide by zero error Flag

The divider is the truncated division and needs a software triggered start signal by using the control register "START" bit. After 8 clock cycles, the divider calculate complete flag will be set to 1, and if the divisor register data is zero, the divide by zero error flag will be set to 1.

### **Analog to Digital Converter – ADC**

- 12-bit SAR ADC engine
- Up to 1 Msps conversion rate
- Up to 6 external analog input channels

A 12-bit multi-channel Analog to Digital Converter is integrated in the device. There are multiplexed channels, which include 6 external analog signal channels and 2 internal channels which can be measured. If the input voltage is required to remain within a specific threshold window, an Analog Watchdog function will monitor and detect these signals. An interrupt will then be generated to inform the device that the input voltage is not within the preset thresholds. There are three conversion modes to convert an analog signal to digital data. The ADC can be operated in one shot, continuous and discontinuous conversion modes.

### I/O Ports - GPIO

- Up to 22 GPIOs
- Port A, B, C are mapped as 13-line EXTI interrupts
- Almost all I/O pins have configurable output driving current

There are up to 22 General Purpose I/O pins, GPIO, for the implementation of logic input/output functions. Each of the GPIO ports has a series of related control and configuration registers to maximize flexibility and to meet the requirements of a wide range of applications.

The GPIO ports are pin-shared with other alternative functions to obtain maximum functional flexibility on the package pins. The GPIO pins can be used as alternative functional pins by configuring the corresponding registers regardless of the input or output pins. The external interrupts on the GPIO pins of the device have related control and configuration registers in the External Interrupt Control Unit, EXTI.



### **Basic Function Timer – BFTM**

- 32-bit compare match count-up counter no I/O control
- One shot mode counter stops counting when compare match occurs
- Repetitive mode counter restarts when compare match occurs

The Basic Function Timer Module, BFTM, is a simple 32-bit up-counting counter designed to measure time intervals, generate one shots or generate repetitive interrupts. The BFTM can operate in two modes, repetitive and one shot modes. In the repetitive mode, the counter will restart at each compare match event. The BFTM also supports a one shot mode which will force the counter to stop counting when a compare match event occurs.

### **Motor Control Timer – MCTM**

- 16-bit up, down, up/down auto-reload counter
- 16-bit programmable prescaler that allows division of the prescaler clock source by any factor between 1 and 65536 to generate the counter clock frequency
- Input Capture function
- Compare Match Output
- PWM waveform generation with Edge-aligned and Center-aligned Counting Modes
- Single Pulse Mode Output
- Complementary Outputs with programmable dead-time insertion
- Break input to force the timer's output signals into a reset or fixed condition

The Motor Control Timer consists of one 16-bit up/down-counter, four 16-bit Capture/Compare Registers (CCRs), one 16-bit Counter Reload Register (CRR), one 8-bit repetition counter and several control/status registers. It can be used for a variety of purposes including measuring the pulse width of input signals or generating output waveforms such as compare match outputs, PWM outputs or complementary PWM outputs with dead-time insertion. The MCTM is capable of offering full functional support for motor control, hall sensor interfacing and break input.

## **General-Purpose Timer – GPTM**

- 16-bit up, down, up/down auto-reload counter
- Up to 4 independent channels for each timer
- 16-bit programmable prescaler that allows division of the prescaler clock source by any factor between 1 and 65536 to generate the counter clock frequency
- Input Capture function
- Compare Match Output
- PWM waveform generation with Edge-aligned and Center-aligned
- Single Pulse Mode Output
- Encoder interface controller with two inputs using quadrature decoder

The General-Purpose Timer, GPTM, consists of one 16-bit up/down-counter, four 16-bit Capture/Compare Registers (CCRs), one 16-bit Counter Reload Register (CRR) and several control/status registers. They can be used for a variety of purposes including general time measurement, input signal pulse width measurement, output waveform generation such as single pulse generation or PWM output generation. The GPTM supports an Encoder Interface using a decoder with two inputs.



### Pulse Width Modulation - PWM

- 16-bit up, down, up/down auto-reload counter
- Up to 4 independent channels for each timer
- 16-bit programmable prescaler that allows division of the prescaler clock source by any factor between 1 and 65536 to generate the counter clock frequency
- Compare Match Output
- PWM waveform generation with Edge-aligned and Center-aligned
- Single Pulse Mode Output

The Pulse Width Modulator, PWM, consists of one 16-bit up/down-counter, four 16-bit Compare Registers (CRs), one 16-bit Counter-Reload Register (CRR) and several control/status registers. It can be used for a variety of purposes including general timer and output waveform generation such as single pulse generation or PWM output.

### Watchdog Timer - WDT

- 12-bit down counter with 3-bit prescaler
- Provide reset to the system
- Programmable watchdog timer window function
- Register write protection function

The Watchdog Timer is a hardware timing circuit that can be used to detect a system lock-up due to software trapped in a deadlock. It includes a 12-bit count-down counter, a prescaler, a WDT delta value register, WDT operation control circuitry and a WDT protection mechanism. If the software does not reload the counter value before a Watchdog Timer underflow occurs, a reset will be generated when the counter underflows. In addition, a reset is also generated if the software reloads the counter when it reaches a delta value. This means the counter must be reloaded within a limited timing window using a specific method. The Watchdog Timer counter can be stopped while the processor is in the debug mode. The register write protect function which can be enabled to prevent an unexpected change in the Watchdog timer configuration.

## Inter-integrated Circuit - I<sup>2</sup>C

- Supports both master and slave modes with a frequency of up to 1 MHz
- Provides an arbitration function and clock synchronization
- Supports 7-bit and 10-bit addressing modes and general call addressing
- Supports slave multi-addressing mode with address mask function

The I<sup>2</sup>C is an internal circuit allowing communication with an external I<sup>2</sup>C interface which is an industry standard two line serial interface used for connection to external hardware. These two serial lines are known as a serial data line, SDA, and a serial clock line, SCL. The I<sup>2</sup>C module provides three data transfer rates: 100 kHz in the Standard mode, 400 kHz in the Fast mode and 1 MHz in the Fast plus mode. The SCL period generation register is used to setup different kinds of duty cycle implementations for the SCL pulse.

The SDA line which is connected directly to the I<sup>2</sup>C bus is a bi-directional data line between the master and slave devices and is used for data transmission and reception. The I<sup>2</sup>C also has an arbitration detect function and clock synchronization to prevent situations where more than one master attempts to transmit data to the I<sup>2</sup>C bus at the same time.

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### Serial Peripheral Interface-SPI

- Supports both master and slave modes
- Frequency of up to  $(f_{PCLK}/2)$  MHz for the master mode and  $(f_{PCLK}/3)$  MHz for the slave mode
- FIFO Depth: 8 levels
- Multi-master and multi-slave operation

The Serial Peripheral Interface, SPI, provides a SPI protocol data transmit and receive function in both master and slave modes. The SPI interface uses 4 pins, which are the serial data input and output lines MISO and MOSI, the clock line, SCK, and the slave select line, SEL. One SPI device acts as a master device which controls the data flow using the SEL and SCK signals to indicate the start of data communication and the data sampling rate. To receive a data byte, the streamed data bits are latched on a specific clock edge and stored in the data register or in the RX FIFO. Data transmission is carried out in a similar way but in a reverse sequence. The mode fault detection provides a capability for multi-master applications.

### Universal Synchronous Asynchronous Receiver Transmitter – USART

- Supports both asynchronous and clocked synchronous serial communication modes
- Programmable baud rate clock frequency up to  $(f_{PCLK}/16)$  MHz for Asynchronous mode and  $(f_{PCLK}/8)$  MHz for synchronous mode
- Full duplex communication
- Fully programmable serial communication characteristics including:
  - Word length: 7, 8 or 9-bit character
  - Parity: Even, odd or no-parity bit generation and detection
  - Stop bit: 1 or 2 stop bit generation
  - Bit order: LSB-first or MSB-first transfer
- Error detection: Parity, overrun and frame error
- Auto hardware flow control mode RTS, CTS
- IrDA SIR encoder and decoder
- RS485 mode with output enable control
- FIFO Depth: 8 × 9 bits for both receiver and transmitter

The Universal Synchronous Asynchronous Receiver Transceiver, USART, provides a flexible full duplex data exchange using synchronous or asynchronous transfer. The USART is used to translate data between parallel and serial interfaces, and is commonly used for RS232 standard communication. The USART peripheral function supports four types of interrupt including Line Status Interrupt, Transmitter FIFO Empty Interrupt, Receiver Threshold Level Reaching Interrupt and Time Out Interrupt. The USART module includes a transmitter FIFO (TX\_FIFO) and receiver FIFO (RX\_FIFO). The software can detect a USART error status by reading the USART Status & Interrupt Flag Register, USRSIFR. The status includes the type and the condition of transfer operations as well as several error conditions resulting from Parity, Overrun, Framing and Break events.



### **Universal Asynchronous Receiver Transmitter – UART**

- Asynchronous serial communication operating baud-rate clock frequency up to (f<sub>PCLK</sub>/16) MHz
- Full duplex communication
- Fully programmable serial communication characteristics including:
  - Word length: 7, 8 or 9-bit character
  - Parity: Even, odd or no-parity bit generation and detection
  - Stop bit: 1 or 2 stop bit generation
  - Bit order: LSB-first or MSB-first transfer
- Error detection: Parity, overrun and frame error

The Universal Asynchronous Receiver Transceiver, UART, provides a flexible full duplex data exchange using asynchronous transfer. The UART is used to translate data between parallel and serial interfaces, and is commonly used for RS232 standard communication. The UART peripheral function supports Line Status Interrupt. The software can detect a UART error status by reading the UART Status & Interrupt Flag Register, URSIFR. The status includes the type and the condition of transfer operations as well as several error conditions resulting from Parity, Overrun, Framing and Break events.

## Cyclic Redundancy Check - CRC

- Support CRC16 polynomial: 0x8005,
  - $X^{16} + X^{15} + X^2 + 1$
- Support CCITT CRC16 polynomial: 0x1021,  $X^{16} + X^{12} + X^5 + 1$
- Support IEEE-802.3 CRC32 polynomial: 0x04C11DB7,  $X^{32} + X^{26} + X^{23} + X^{22} + X^{16} + X^{12} + X^{11} + X^{10} + X^{8} + X^{7} + X^{5} + X^{4} + X^{2} + X + 1$
- Supports 1's complement, byte reverse & bit reverse operation on data and checksum
- Supports byte, half-word & word data size
- Programmable CRC initial seed value
- CRC computation executed in 1 AHB clock cycle for 8-bit data and 4 AHB clock cycles for 32-bit data

The CRC calculation unit is an error detection technique test algorithm which is used to verify data transmission or storage data correctness. A CRC calculation takes a data stream or a block of data as its input and generates a 16-bit or 32-bit output remainder. Ordinarily, a data stream is suffixed by a CRC code and used as a checksum when being sent or stored. Therefore, the received or restored data stream is calculated by the same generator polynomial as described above. If the new CRC code result does not match the one calculated earlier, that means the data stream contains a data error.

## **Debug Support**

- Serial Wire Debug Port SW-DP
- 4 comparators for hardware breakpoint or code / literal patch
- 2 comparators for hardware watch points

## **Package and Operation Temperature**

- 48-pin LQFP-EP package
- Operation temperature range: -40 °C to 85 °C



# **3** Overview

### **Device Information**

**Table 1. Features and Peripheral List** 

Peripherals		HT32F61641				
Main Flash (KB)		63				
Option Bytes Flash (kg	(B)	1				
SRAM (KB)		8				
	MCTM	1				
	GPTM	1				
Timers	PWM	2				
Timers	BFTM	2				
	WDT	1				
	RTC	1				
	SPI	2				
Communication	USART	1				
Communication	UART	1				
	I <sup>2</sup> C	2				
Hardware Divider		1				
CRC-16/32		1				
EXTI		13				
12-bit ADC		1				
Number of channels		6 Channels				
GPIO		22				
CPU frequency		Up to 20 MHz				
Operating voltage		2.5 V ~ 5.5 V				
Operating temperatur	е	-40 °C ~ 85 °C				
Package		48-pin LQFP-EP				



## **Block Diagram**

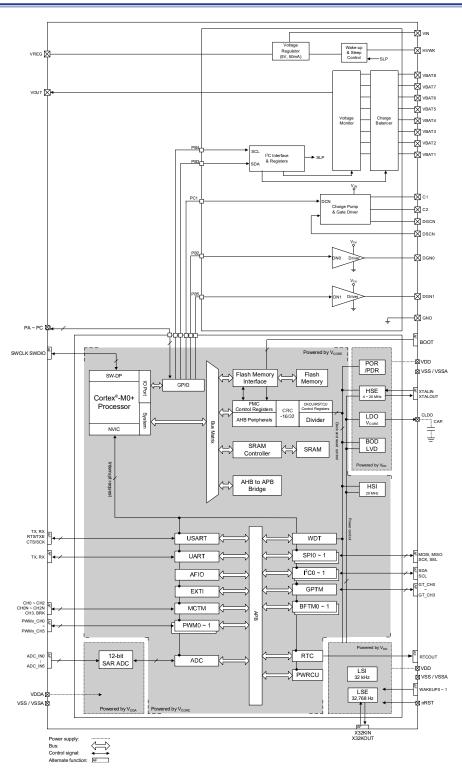


Figure 1. Block Diagram



## **Memory Map**

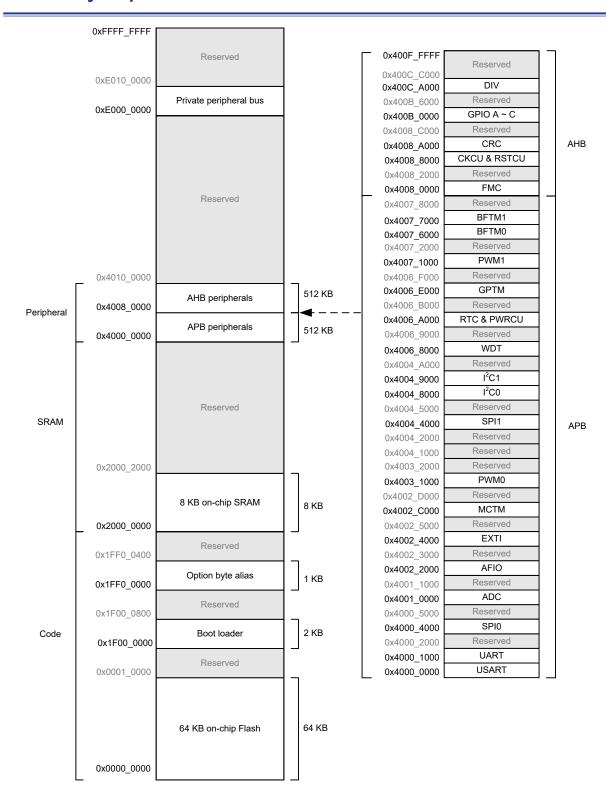


Figure 2. Memory Map



Table 2. Register Map

0x4000_0000         0x4000_0FFF         USART           0x4000_1000         0x4000_1FFF         UART           0x4000_2000         0x4000_3FFF         Reserved           0x4000_4000         0x4000_4FFF         SPI0           0x4000_5000         0x4000_FFFF         Reserved           0x4001_0000         0x4000_1FFF         ADC           0x4001_1000         0x4002_1FFF         Reserved           0x4002_2000         0x4002_2FFF         AFIO           0x4002_3000         0x4002_3FFF         Reserved           0x4002_4000         0x4002_4FFF         EXTI           0x4002_5000         0x4002_BFFF         Reserved           0x4002_0000         0x4002_FFF         MCTM           0x4002_0000         0x4003_1FFF         Reserved           0x4003_1000         0x4004_0FFF         Reserved           0x4004_1000         0x4004_1FFF         Reserved           0x4004_2000         0x4004_3FFF         Reserved           0x4004_4000         0x4004_3FFF         Reserved           0x4004_8000         0x4004_8FFF         I²C1           0x4004_8000         0x4004_8FFF         I²C1           0x4004_8000         0x4004_8FFF         Reserved	Start Address	End Address	Peripheral	Bus
0x4000_2000         0x4000_3FFF         Reserved           0x4000_4000         0x4000_4FFF         SPI0           0x4000_5000         0x4000_FFFF         Reserved           0x4001_0000         0x4001_0FFF         ADC           0x4001_1000         0x4002_1FFF         Reserved           0x4002_2000         0x4002_2FFF         AFIO           0x4002_3000         0x4002_3FFF         Reserved           0x4002_4000         0x4002_4FFF         EXTI           0x4002_5000         0x4002_BFFF         Reserved           0x4002_5000         0x4002_CFFF         MCTM           0x4002_0000         0x4003_1FFF         PWM0           0x4003_1000         0x4003_1FFF         PWM0           0x4003_1000         0x4004_0FFF         Reserved           0x4004_1000         0x4004_1FFF         Reserved           0x4004_1000         0x4004_1FFF         Reserved           0x4004_2000         0x4004_3FFF         Reserved           0x4004_4000         0x4004_7FFF         Reserved           0x4004_8000         0x4004_9FFF         I²C1           0x4004_8000         0x4006_7FF         Reserved           0x4006_8000         0x4006_9FF         Reserved <t< td=""><td>0x4000_0000</td><td>0x4000_0FFF</td><td>USART</td><td></td></t<>	0x4000_0000	0x4000_0FFF	USART	
0x4000_4000         0x4000_4FFF         SPI0           0x4000_5000         0x4000_FFFF         Reserved           0x4001_0000         0x4001_0FFF         ADC           0x4001_1000         0x4002_1FFF         Reserved           0x4002_2000         0x4002_2FFF         AFIO           0x4002_3000         0x4002_3FFF         Reserved           0x4002_4000         0x4002_4FFF         EXTI           0x4002_5000         0x4002_BFFF         Reserved           0x4002_C000         0x4002_CFFF         MCTM           0x4002_D000         0x4003_1FFF         PWM0           0x4003_1000         0x4003_1FFF         PWM0           0x4003_1000         0x4004_1FFF         Reserved           0x4004_1000         0x4004_1FFF         Reserved           0x4004_1000         0x4004_1FFF         Reserved           0x4004_2000         0x4004_1FFF         Reserved           0x4004_4000         0x4004_1FFF         Reserved           0x4004_8000         0x4004_1FFF         Reserved           0x4004_8000         0x4004_1FFF         Reserved           0x4004_9000         0x4006_1FFF         Reserved           0x4006_8000         0x4006_1FFF         Reserved	0x4000_1000	0x4000_1FFF	UART	
0x4000_5000         0x4000_FFFF         Reserved           0x4001_0000         0x4001_0FFF         ADC           0x4001_1000         0x4002_1FFF         Reserved           0x4002_2000         0x4002_2FFF         AFIO           0x4002_3000         0x4002_3FFF         Reserved           0x4002_4000         0x4002_4FFF         EXTI           0x4002_5000         0x4002_BFFF         Reserved           0x4002_C000         0x4002_CFFF         MCTM           0x4002_D000         0x4003_0FFF         Reserved           0x4003_1000         0x4003_1FF         PWM0           0x4003_2000         0x4004_0FFF         Reserved           0x4004_1000         0x4004_1FFF         Reserved           0x4004_2000         0x4004_3FFF         Reserved           0x4004_2000         0x4004_4FFF         SPI1           0x4004_5000         0x4004_8FFF         I²C0           0x4004_8000         0x4004_8FFF         I²C1           0x4004_8000         0x4004_9FFF         Reserved           0x4004_8000         0x4006_8FF         WDT           0x4006_8000         0x4006_8FF         Reserved           0x4006_8000         0x4006_BFF         Reserved           0x400	0x4000_2000	0x4000_3FFF	Reserved	
0x4001_0000         0x4001_0FFF         ADC           0x4001_1000         0x4002_1FFF         Reserved           0x4002_2000         0x4002_2FFF         AFIO           0x4002_3000         0x4002_3FFF         Reserved           0x4002_4000         0x4002_4FFF         EXTI           0x4002_5000         0x4002_BFFF         Reserved           0x4002_C000         0x4002_CFFF         MCTM           0x4002_D000         0x4003_0FFF         Reserved           0x4003_1000         0x4003_1FFF         PWM0           0x4003_2000         0x4004_0FFF         Reserved           0x4004_1000         0x4004_0FFF         Reserved           0x4004_2000         0x4004_3FFF         Reserved           0x4004_2000         0x4004_4FFF         SPI1           0x4004_4000         0x4004_4FFF         SPI1           0x4004_8000         0x4004_8FFF         I²C0           0x4004_8000         0x4004_9FFF         I²C1           0x4004_A000         0x4004_9FFF         I²C1           0x4006_8000         0x4006_8FF         WDT           0x4006_8000         0x4006_BFF         Reserved           0x4006_B000         0x4006_BFF         Reserved           0x4006_B000<	0x4000_4000	0x4000_4FFF	SPI0	
0x4001_1000         0x4002_1FFF         Reserved           0x4002_2000         0x4002_2FFF         AFIO           0x4002_3000         0x4002_3FFF         Reserved           0x4002_4000         0x4002_4FFF         EXTI           0x4002_5000         0x4002_BFFF         Reserved           0x4002_C000         0x4002_CFFF         MCTM           0x4002_D000         0x4003_0FFF         Reserved           0x4003_1000         0x4003_1FFF         PWM0           0x4003_2000         0x4004_0FFF         Reserved           0x4004_1000         0x4004_0FFF         Reserved           0x4004_2000         0x4004_3FFF         Reserved           0x4004_2000         0x4004_3FFF         Reserved           0x4004_3000         0x4004_8FFF         I²C0           0x4004_3000         0x4004_8FFF         I²C1           0x4004_3000         0x4004_9FFF         I²C1           0x4004_3000         0x4006_8FF         WDT           0x4006_8000         0x4006_8FF         WDT           0x4006_8000         0x4006_AFFF         RTC & PWRCU           0x4006_B000         0x4006_BFF         GPTM           0x4006_B000         0x4007_0FFF         Reserved           0x400	0x4000_5000	0x4000_FFFF	Reserved	
0x4002_2000         0x4002_2FFF         AFIO           0x4002_3000         0x4002_3FFF         Reserved           0x4002_4000         0x4002_4FFF         EXTI           0x4002_5000         0x4002_BFFF         Reserved           0x4002_C000         0x4002_CFFF         MCTM           0x4002_D000         0x4003_0FFF         Reserved           0x4003_1000         0x4003_1FFF         PWM0           0x4003_2000         0x4004_0FFF         Reserved           0x4004_1000         0x4004_0FFF         Reserved           0x4004_2000         0x4004_3FFF         Reserved           0x4004_2000         0x4004_4FFF         SPI1           0x4004_3000         0x4004_8FFF         I²CO           0x4004_3000         0x4004_8FFF         I²C1           0x4004_3000         0x4004_9FFF         I²C1           0x4004_3000         0x4006_8FF         WDT           0x4006_8000         0x4006_8FF         WDT           0x4006_8000         0x4006_AFF         RTC & PWRCU           0x4006_B000         0x4006_AFF         GPTM           0x4006_B000         0x4006_FFF         GPTM           0x4006_F000         0x4007_0FFF         Reserved           0x4007_1000 <td>0x4001_0000</td> <td>0x4001_0FFF</td> <td>ADC</td> <td></td>	0x4001_0000	0x4001_0FFF	ADC	
0x4002_3000         0x4002_3FFF         Reserved           0x4002_4000         0x4002_4FFF         EXTI           0x4002_5000         0x4002_BFFF         Reserved           0x4002_C000         0x4002_CFFF         MCTM           0x4002_D000         0x4003_0FFF         Reserved           0x4003_1000         0x4003_1FFF         PWM0           0x4003_2000         0x4004_0FFF         Reserved           0x4004_1000         0x4004_1FFF         Reserved           0x4004_2000         0x4004_3FFF         Reserved           0x4004_2000         0x4004_4FFF         SPI1           0x4004_5000         0x4004_7FFF         Reserved           0x4004_8000         0x4004_8FFF         I²C0           0x4004_9000         0x4004_9FFF         I²C1           0x4004_9000         0x4006_7FFF         Reserved           0x4006_8000         0x4006_8FFF         WDT           0x4006_8000         0x4006_9FFF         Reserved           0x4006_B000         0x4006_DFFF         Reserved           0x4006_B000         0x4006_DFFF         Reserved           0x4006_B000         0x4006_DFFF         Reserved           0x4006_F000         0x4007_OFFF         Reserved	0x4001_1000	0x4002_1FFF	Reserved	
0x4002_4000         0x4002_4FFF         EXTI           0x4002_5000         0x4002_BFFF         Reserved           0x4002_C000         0x4002_CFFF         MCTM           0x4002_D000         0x4003_0FFF         Reserved           0x4003_1000         0x4003_1FFF         PWM0           0x4003_2000         0x4004_0FFF         Reserved           0x4004_1000         0x4004_1FFF         Reserved           0x4004_2000         0x4004_3FFF         Reserved           0x4004_2000         0x4004_4FFF         SPI1           0x4004_5000         0x4004_7FFF         Reserved           0x4004_8000         0x4004_8FFF         I²C0           0x4004_9000         0x4004_9FFF         I²C1           0x4004_9000         0x4006_7FFF         Reserved           0x4004_8000         0x4006_7FFF         Reserved           0x4006_8000         0x4006_8FFF         WDT           0x4006_8000         0x4006_9FFF         Reserved           0x4006_B000         0x4006_DFFF         Reserved           0x4006_B000         0x4006_EFFF         GPTM           0x4006_F000         0x4006_EFFF         GPTM           0x4006_F000         0x4007_0FFF         Reserved	0x4002_2000	0x4002_2FFF	AFIO	
0x4002_5000         0x4002_BFFF         Reserved           0x4002_C000         0x4002_CFFF         MCTM           0x4002_D000         0x4003_0FFF         Reserved           0x4003_1000         0x4003_1FFF         PWM0           0x4003_2000         0x4004_0FFF         Reserved           0x4004_1000         0x4004_1FFF         Reserved           0x4004_2000         0x4004_3FFF         Reserved           0x4004_2000         0x4004_3FFF         SPI1           0x4004_4000         0x4004_4FFF         SPI1           0x4004_5000         0x4004_8FFF         I²C0           0x4004_8000         0x4004_9FFF         I²C1           0x4004_9000         0x4004_9FFF         I²C1           0x4004_A000         0x4006_8FF         WDT           0x4006_8000         0x4006_9FFF         Reserved           0x4006_9000         0x4006_AFFF         RTC & PWRCU           0x4006_B000         0x4006_BFF         GPTM           0x4006_B000         0x4006_EFFF         GPTM           0x4006_F000         0x4007_0FFF         Reserved           0x4007_1000         0x4007_5FFF         Reserved           0x4007_6000         0x4007_6FFF         BFTM0           0x4007	0x4002_3000	0x4002_3FFF	Reserved	
0x4002_C000         0x4002_CFFF         MCTM           0x4002_D000         0x4003_0FFF         Reserved           0x4003_1000         0x4003_1FFF         PWM0           0x4003_2000         0x4004_0FFF         Reserved           0x4004_1000         0x4004_1FFF         Reserved           0x4004_2000         0x4004_3FFF         Reserved           0x4004_2000         0x4004_3FFF         SPI1           0x4004_4000         0x4004_4FFF         SPI1           0x4004_5000         0x4004_7FFF         Reserved           0x4004_8000         0x4004_9FFF         I²C0           0x4004_9000         0x4006_7FFF         Reserved           0x4004_A000         0x4006_7FFF         Reserved           0x4006_8000         0x4006_8FFF         WDT           0x4006_9000         0x4006_AFFF         RTC & PWRCU           0x4006_B000         0x4006_DFFF         Reserved           0x4006_B000         0x4006_FFF         GPTM           0x4006_F000         0x4007_0FFF         Reserved           0x4007_1000         0x4007_1FFF         PWM1           0x4007_6000         0x4007_6FFF         BFTM0           0x4007_7000         0x4007_7FFF         BFTM1	0x4002_4000	0x4002_4FFF	EXTI	
0x4002_D000         0x4003_0FFF         Reserved           0x4003_1000         0x4003_1FFF         PWM0           0x4003_2000         0x4004_0FFF         Reserved           0x4004_1000         0x4004_1FFF         Reserved           0x4004_2000         0x4004_3FFF         Reserved           0x4004_2000         0x4004_3FFF         SPI1           0x4004_5000         0x4004_7FFF         Reserved           0x4004_8000         0x4004_8FFF         I²C0           0x4004_9000         0x4004_9FFF         I²C1           0x4004_A000         0x4006_7FFF         Reserved           0x4006_8000         0x4006_8FFF         WDT           0x4006_9000         0x4006_9FFF         Reserved           0x4006_B000         0x4006_AFFF         RTC & PWRCU           0x4006_B000         0x4006_FFF         GPTM           0x4006_F000         0x4007_0FFF         Reserved           0x4007_1000         0x4007_1FFF         PWM1           0x4007_2000         0x4007_5FFF         Reserved           0x4007_7000         0x4007_7FFF         BFTM0           0x4007_7000         0x4007_7FFF         BFTM1	0x4002_5000	0x4002_BFFF	Reserved	
0x4003_1000         0x4003_1FFF         PWM0           0x4003_2000         0x4004_0FFF         Reserved           0x4004_1000         0x4004_1FFF         Reserved           0x4004_2000         0x4004_3FFF         Reserved           0x4004_4000         0x4004_4FFF         SPI1           0x4004_5000         0x4004_7FFF         Reserved           0x4004_8000         0x4004_8FFF         I²C0           0x4004_9000         0x4004_9FFF         I²C1           0x4004_A000         0x4006_7FFF         Reserved           0x4006_8000         0x4006_8FFF         WDT           0x4006_9000         0x4006_9FFF         Reserved           0x4006_B000         0x4006_DFFF         Reserved           0x4006_B000         0x4006_DFFF         GPTM           0x4006_F000         0x4007_0FFF         Reserved           0x4007_1000         0x4007_1FFF         PWM1           0x4007_2000         0x4007_5FFF         BFTM0           0x4007_7000         0x4007_7FFF         BFTM1	0x4002_C000	0x4002_CFFF	MCTM	
0x4003_2000         0x4004_0FFF         Reserved           0x4004_1000         0x4004_1FFF         Reserved           0x4004_2000         0x4004_3FFF         Reserved           0x4004_4000         0x4004_4FFF         SPI1           0x4004_5000         0x4004_7FFF         Reserved           0x4004_8000         0x4004_8FFF         I²C0           0x4004_9000         0x4004_9FFF         I²C1           0x4004_A000         0x4006_7FFF         Reserved           0x4006_8000         0x4006_8FFF         WDT           0x4006_9000         0x4006_9FFF         Reserved           0x4006_A000         0x4006_AFFF         RTC & PWRCU           0x4006_B000         0x4006_FFF         GPTM           0x4006_E000         0x4007_0FFF         Reserved           0x4006_F000         0x4007_1FFF         PWM1           0x4007_2000         0x4007_5FFF         Reserved           0x4007_6000         0x4007_7FFF         BFTM0           0x4007_7000         0x4007_7FFF         BFTM1	0x4002_D000	0x4003_0FFF	Reserved	
0x4004_1000         0x4004_1FFF         Reserved           0x4004_2000         0x4004_3FFF         Reserved           0x4004_4000         0x4004_4FFF         SPI1           0x4004_5000         0x4004_7FFF         Reserved           0x4004_8000         0x4004_8FFF         I²C0           0x4004_9000         0x4004_9FFF         I²C1           0x4004_A000         0x4006_7FFF         Reserved           0x4006_8000         0x4006_8FFF         WDT           0x4006_9000         0x4006_9FFF         Reserved           0x4006_A000         0x4006_AFFF         RTC & PWRCU           0x4006_B000         0x4006_DFFF         Reserved           0x4006_B000         0x4006_FFF         GPTM           0x4006_F000         0x4007_0FFF         Reserved           0x4007_1000         0x4007_1FFF         PWM1           0x4007_2000         0x4007_5FFF         Reserved           0x4007_6000         0x4007_7FFF         BFTM0           0x4007_7000         0x4007_7FFF         BFTM1	0x4003_1000	0x4003_1FFF	PWM0	
0x4004_2000         0x4004_3FFF         Reserved           0x4004_4000         0x4004_4FFF         SPI1           0x4004_5000         0x4004_7FFF         Reserved           0x4004_8000         0x4004_8FFF         I²C0           0x4004_9000         0x4004_9FFF         I²C1           0x4004_A000         0x4006_7FFF         Reserved           0x4006_8000         0x4006_8FFF         WDT           0x4006_9000         0x4006_9FFF         Reserved           0x4006_A000         0x4006_AFFF         RTC & PWRCU           0x4006_B000         0x4006_DFFF         Reserved           0x4006_E000         0x4006_EFFF         GPTM           0x4006_F000         0x4007_0FFF         Reserved           0x4007_1000         0x4007_1FFF         PWM1           0x4007_2000         0x4007_5FFF         Reserved           0x4007_6000         0x4007_7FFF         BFTM0           0x4007_7000         0x4007_7FFF         BFTM1	0x4003_2000	0x4004_0FFF	Reserved	
0x4004_4000         0x4004_4FFF         SPI1           0x4004_5000         0x4004_7FFF         Reserved           0x4004_8000         0x4004_8FFF         I²C0           0x4004_9000         0x4004_9FFF         I²C1           0x4004_A000         0x4006_7FFF         Reserved           0x4006_8000         0x4006_8FFF         WDT           0x4006_9000         0x4006_9FFF         Reserved           0x4006_A000         0x4006_AFFF         RTC & PWRCU           0x4006_B000         0x4006_DFFF         Reserved           0x4006_E000         0x4006_EFFF         GPTM           0x4006_F000         0x4007_0FFF         Reserved           0x4007_1000         0x4007_1FFF         PWM1           0x4007_2000         0x4007_5FFF         Reserved           0x4007_6000         0x4007_6FFF         BFTM0           0x4007_7000         0x4007_7FFF         BFTM1	0x4004_1000	0x4004_1FFF	Reserved	
0x4004_5000         0x4004_7FFF         Reserved           0x4004_8000         0x4004_8FFF         I²C0           0x4004_9000         0x4004_9FFF         I²C1           0x4004_A000         0x4006_7FFF         Reserved           0x4006_8000         0x4006_8FFF         WDT           0x4006_9000         0x4006_9FFF         Reserved           0x4006_A000         0x4006_AFFF         RTC & PWRCU           0x4006_B000         0x4006_DFFF         Reserved           0x4006_E000         0x4006_EFFF         GPTM           0x4006_F000         0x4007_0FFF         Reserved           0x4007_1000         0x4007_1FFF         PWM1           0x4007_2000         0x4007_5FFF         Reserved           0x4007_6000         0x4007_6FFF         BFTM0           0x4007_7000         0x4007_7FFF         BFTM1	0x4004_2000	0x4004_3FFF	Reserved	APB
0x4004_8000         0x4004_8FFF         I²C0           0x4004_9000         0x4004_9FFF         I²C1           0x4004_A000         0x4006_7FFF         Reserved           0x4006_8000         0x4006_8FFF         WDT           0x4006_9000         0x4006_9FFF         Reserved           0x4006_A000         0x4006_AFFF         RTC & PWRCU           0x4006_B000         0x4006_DFFF         Reserved           0x4006_E000         0x4006_EFFF         GPTM           0x4006_F000         0x4007_0FFF         Reserved           0x4007_1000         0x4007_1FFF         PWM1           0x4007_2000         0x4007_5FFF         Reserved           0x4007_6000         0x4007_6FFF         BFTM0           0x4007_7000         0x4007_7FFF         BFTM1	0x4004_4000	0x4004_4FFF	SPI1	
0x4004_9000         0x4004_9FFF         I²C1           0x4004_A000         0x4006_7FFF         Reserved           0x4006_8000         0x4006_8FFF         WDT           0x4006_9000         0x4006_9FFF         Reserved           0x4006_A000         0x4006_AFFF         RTC & PWRCU           0x4006_B000         0x4006_DFFF         Reserved           0x4006_E000         0x4006_EFFF         GPTM           0x4006_F000         0x4007_0FFF         Reserved           0x4007_1000         0x4007_1FFF         PWM1           0x4007_2000         0x4007_5FFF         Reserved           0x4007_6000         0x4007_6FFF         BFTM0           0x4007_7000         0x4007_7FFF         BFTM1	0x4004_5000	0x4004_7FFF	Reserved	
0x4004_A000         0x4006_7FFF         Reserved           0x4006_8000         0x4006_8FFF         WDT           0x4006_9000         0x4006_9FFF         Reserved           0x4006_A000         0x4006_AFFF         RTC & PWRCU           0x4006_B000         0x4006_DFFF         Reserved           0x4006_E000         0x4006_EFFF         GPTM           0x4006_F000         0x4007_0FFF         Reserved           0x4007_1000         0x4007_1FFF         PWM1           0x4007_2000         0x4007_5FFF         Reserved           0x4007_6000         0x4007_6FFF         BFTM0           0x4007_7000         0x4007_7FFF         BFTM1	0x4004_8000	0x4004_8FFF	I <sup>2</sup> C0	
0x4006_8000         0x4006_8FFF         WDT           0x4006_9000         0x4006_9FFF         Reserved           0x4006_A000         0x4006_AFFF         RTC & PWRCU           0x4006_B000         0x4006_DFFF         Reserved           0x4006_E000         0x4006_EFFF         GPTM           0x4006_F000         0x4007_0FFF         Reserved           0x4007_1000         0x4007_1FFF         PWM1           0x4007_2000         0x4007_5FFF         Reserved           0x4007_6000         0x4007_6FFF         BFTM0           0x4007_7000         0x4007_7FFF         BFTM1	0x4004_9000	0x4004_9FFF	I <sup>2</sup> C1	
0x4006_9000         0x4006_9FFF         Reserved           0x4006_A000         0x4006_AFFF         RTC & PWRCU           0x4006_B000         0x4006_DFFF         Reserved           0x4006_E000         0x4006_EFFF         GPTM           0x4006_F000         0x4007_0FFF         Reserved           0x4007_1000         0x4007_1FFF         PWM1           0x4007_2000         0x4007_5FFF         Reserved           0x4007_6000         0x4007_6FFF         BFTM0           0x4007_7000         0x4007_7FFF         BFTM1	0x4004_A000	0x4006_7FFF	Reserved	
0x4006_A000         0x4006_AFFF         RTC & PWRCU           0x4006_B000         0x4006_DFFF         Reserved           0x4006_E000         0x4006_EFFF         GPTM           0x4006_F000         0x4007_0FFF         Reserved           0x4007_1000         0x4007_1FFF         PWM1           0x4007_2000         0x4007_5FFF         Reserved           0x4007_6000         0x4007_6FFF         BFTM0           0x4007_7000         0x4007_7FFF         BFTM1	0x4006_8000	0x4006_8FFF	WDT	
0x4006_B000         0x4006_DFFF         Reserved           0x4006_E000         0x4006_EFFF         GPTM           0x4006_F000         0x4007_0FFF         Reserved           0x4007_1000         0x4007_1FFF         PWM1           0x4007_2000         0x4007_5FFF         Reserved           0x4007_6000         0x4007_6FFF         BFTM0           0x4007_7000         0x4007_7FFF         BFTM1	0x4006_9000	0x4006_9FFF	Reserved	
0x4006_E000         0x4006_EFFF         GPTM           0x4006_F000         0x4007_0FFF         Reserved           0x4007_1000         0x4007_1FFF         PWM1           0x4007_2000         0x4007_5FFF         Reserved           0x4007_6000         0x4007_6FFF         BFTM0           0x4007_7000         0x4007_7FFF         BFTM1	0x4006_A000	0x4006_AFFF	RTC & PWRCU	
0x4006_F000         0x4007_0FFF         Reserved           0x4007_1000         0x4007_1FFF         PWM1           0x4007_2000         0x4007_5FFF         Reserved           0x4007_6000         0x4007_6FFF         BFTM0           0x4007_7000         0x4007_7FFF         BFTM1	0x4006_B000	0x4006_DFFF	Reserved	
0x4007_1000         0x4007_1FFF         PWM1           0x4007_2000         0x4007_5FFF         Reserved           0x4007_6000         0x4007_6FFF         BFTM0           0x4007_7000         0x4007_7FFF         BFTM1	0x4006_E000	0x4006_EFFF	GPTM	
0x4007_2000         0x4007_5FFF         Reserved           0x4007_6000         0x4007_6FFF         BFTM0           0x4007_7000         0x4007_7FFF         BFTM1	0x4006_F000	0x4007_0FFF	Reserved	
0x4007_6000	0x4007_1000	0x4007_1FFF	PWM1	
0x4007_7000 0x4007_7FFF BFTM1	0x4007_2000	0x4007_5FFF	Reserved	
	0x4007_6000	0x4007_6FFF	BFTM0	
0x4007_8000	0x4007_7000	0x4007_7FFF	BFTM1	
	0x4007_8000	0x4007_FFFF	Reserved	



Start Address	End Address	Peripheral	Bus
0x4008_0000	0x4008_1FFF	FMC	
0x4008_2000	0x4008_7FFF	Reserved	
0x4008_8000	0x4008_9FFF	CKCU & RSTCU	
0x4008_A000	0x4008_BFFF	CRC	
0x4008_C000	0x400A_FFFF	Reserved	
0x400B_0000	0x400B_1FFF	GPIOA	AHB
0x400B_2000	0x400B_3FFF	GPIOB	
0x400B_4000	0x400B_5FFF	GPIOC	
0x400B_6000	0x400C_9FFF	Reserved	
0x400C_A000	0x400C_BFFF	DIV	
0x400C_C000	0x400F_FFFF	Reserved	



### **Clock Structure**

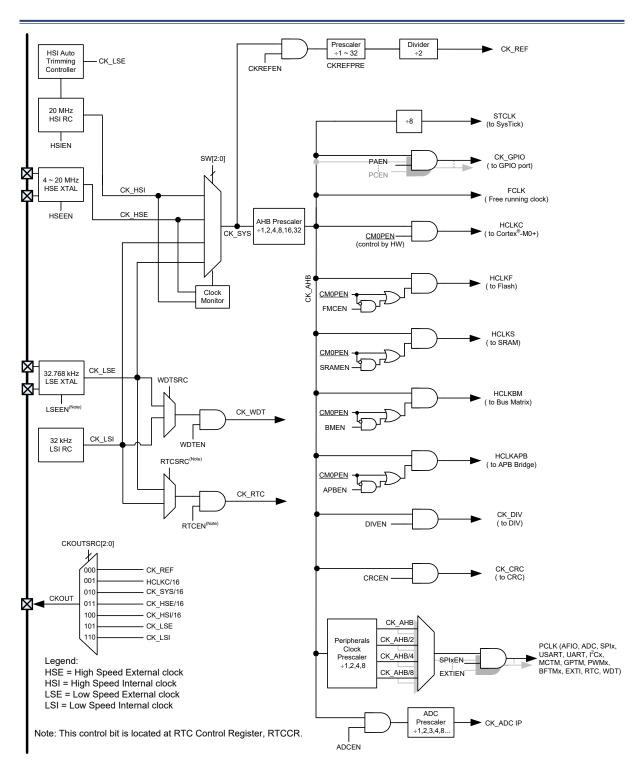


Figure 3. Clock Structure



# 4

## **Accumulative Cell Voltage Monitor**

The Accumulative Cell Voltage Monitor is designed to monitor an accumulative voltage from 1 to N and outputs the divide-by-N voltage to the analog multiplexer. Each divided accumulative cell voltage from pin VBATn can be observed sequentially and measured by using the internal A/D converter, which is only required to externally connect the VOUT pin to the one of the internal A/D converter channels.

The Accumulative Cell Voltage Monitor can directly drive the MCU controlled power N-type MOSFETs to control charge and discharge by charge and discharge gate-drivers. The integrated battery balance circuitry provides a cell balance current without the need of external transistors.

An integrated regulator provides a 5 V supply to the MCU with a 50 mA driving current capability and which has  $\pm 1$  % accuracy. The voltage regulator, cell voltage monitor and gate-drivers are shut down with an ultra-low standby current of 0.1  $\mu$ A when the device is in the Sleep mode. When the HVWK pin is triggered by a voltage greater than its threshold, the device will return to the standby state.

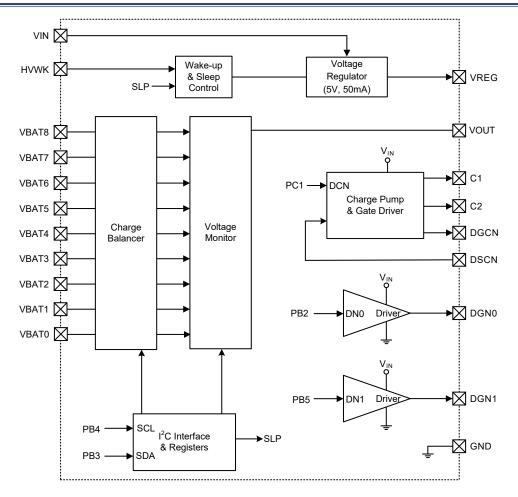


Figure 4. Accumulative Cell Voltage Monitor Block Diagram



### I<sup>2</sup>C Serial Interface Functional Description

The Accumulative cell voltage monitor includes an I<sup>2</sup>C serial interface. The I<sup>2</sup>C bus is used for bidirectional, two-line communication between different ICs or modules. The two lines are a serial data line, SDA, and a serial clock line, SCL. Both lines are open-drain structure and two pull-high resistors are required. When the bus is free, both lines are high. The output stages of devices connected to the bus must have an open-drain or open-collector to implement the Wired-AND function. Data transfer is initiated only when the bus is not busy.

### **Data Validity**

The data on the SDA line must be stable during the clock high period. The high or low state of the data line can only change when the clock signal on the SCL line is low.

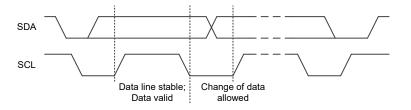


Figure 5. Data Validity

#### START and STOP Conditions

- A high to low transition on the SDA line while SCL is high defines a START (S).
- A low to high transition on the SDA line while SCL is high defines a STOP (P).
- START and STOP are always generated by the master. The bus is considered to be busy after the START. The bus is considered to be free again a certain time after the STOP.
- The bus remains busy if a Repeated START (Sr) is generated instead of a STOP. In the respect, the START and Repeated START are functionally identical.

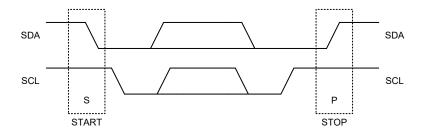


Figure 6. START and STOP Conditions



### **Byte Format**

Every byte placed on the SDA line must be 8-bit long. The number of bytes that can be transmitted per transfer is unrestricted. Each byte has to be followed by an acknowledge bit. Data is transferred with the most significant bit (MSB) first.

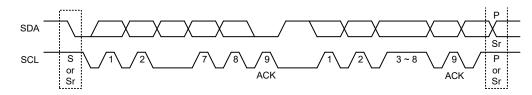


Figure 7. Byte Format

### **Acknowledge**

- Each byte of eight bits is followed by one acknowledge bit. This acknowledge bit is a low level placed on the bus by the receiver, the master generates an extra acknowledge related clock pulse.
- A slave receiver which is addressed must generate an acknowledge (ACK) after the reception of each byte.
- The device that provides an acknowledge must pull down the SDA line during the acknowledge clock pulse so that it remains at a stable low level during the high period of this clock pulse.
- A master receiver must signal an end of data to the slave by generating a not-acknowledge (NACK) bit on the last byte that has been clocked out of the slave. In this case, the master receiver must leave the data line high during the 9<sup>th</sup> pulse so as to not acknowledge. The master will generate a STOP or a Repeated START.

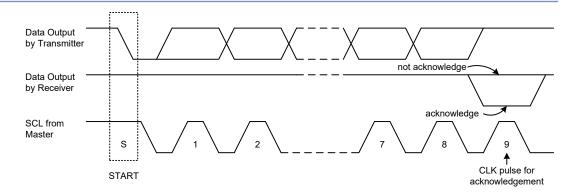


Figure 8. Acknowledge

### I<sup>2</sup>C Time-out Control

In order to reduce the  $I^2C$  lockup problem due to reception of erroneous clock sources, a time-out function is provided. The  $I^2C$  time-out function starts timing for the specified  $I^2C$  time-out period  $(t_{OUT})$  when receiving START (S) from  $I^2C$  bus. The timer is reset by every falling edge of SCL and gets interrupted when receiving STOP (P). If the next falling edge of SCL or STOP (P) does not appear throughout the  $I^2C$  time-out period  $(t_{OUT})$ , the SDA and SCL are set to their default states at the end of timing and meanwhile the registers remains unchanged. The  $I^2C$  time-out period can be specified to 32 ms or 64 ms by Trim-fuse selection.



### **Write Operation**

An I<sup>2</sup>C write operation combines a START bit, a Slave address with a Write bit, a Register command byte, a Data byte and a STOP bit.

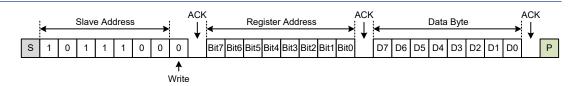


Figure 9. Write Operation Format

### **Read Sequence**

The complete read mode consists of two stages. For the  $1^{st}$  stage, write the Register Address Byte to the device. For the  $2^{nd}$  stage, reads out the Data Byte from the device. The following diagram shows the complete read format.

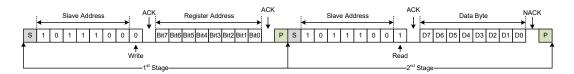


Figure 10. Read Sequence Format

#### Slave Address

- The slave address byte is the first byte received following the START condition from the master device. The first seven bits of the first byte make up the slave address. The eighth bit defines whether a read or write operation is to be performed. When the R/W bit is "1", then a read operation is selected. When the R/W bit is "0", it selects a write operation.
- The slave address of the device is "1011100". When an address byte is sent, the device compares the first seven bits after the START condition. If matched, the device outputs an Acknowledge on the SDA line.



Figure 11. Slave Address Format



### I<sup>2</sup>C Register Map

The I<sup>2</sup>C register map is listed below.

Address	Acronym	Access Type	Value after POR	Register Description
00H	REG00	R/W	0000 0000	Sleep and Voltage monitor
01H	REG01	R/W	0000 0000	Charge balance

#### Sleep and Voltage Monitor Register

Bit	7	6	5	4	3	2	1	0
Name	SLP	EXT_WK	EN_S	Reserved	Reserved	B2	B1	В0
R/W	R/W	R/W	R/W	R/W	R/W	R/W	R/W	R/W
POR	0	0	0	0	0	0	0	0

Bit 7 SLP: Sleep mode enable control

0: Stay in normal operation

1: Start Sleep procedure

At the state of EXT\_WK = "1", SLP is reset to "0" and keep the "0" state until EXT\_WK is cleared to "0". The Sleep command from I<sup>2</sup>C master is ignored during the state of EXT\_WK = "1".

Bit 6 **EXT\_WK**: External wake-up event status

0: Denotes that external wake-up event does not exist

- 1: Denotes that external wake-up event exists or is written by MCU
- (1) When the voltage applied on HVWK pin remains higher than  $V_{WKTH}$  over 10  $\mu$ s, the EXT\_WK will be set to "1" and the SLP will be reset to "0". The EXT\_WK is cleared to "0" immediately when the voltage applied on HVWK pin is less than 1.5 V.
- (2) The EXT\_WK can be written as "1" by MCU for the purpose of sending a wake-up signal. The EXT\_WK and SLP have to be written as "0" through the I<sup>2</sup>C interface after the EXT\_WK is set to "1" by MCU, otherwise the external wake-up event on HVWK pin cannot be recognized and the follow-up Sleep command will be failed.
- (3) Writing both EXT\_WK and SLP as "1" is not permitted for avoiding unpredictable status.
- (4) Reading EXT\_WK reveals the external wake-up even status of the HVWK pin only.

Bit 5 EN S: Voltage monitor function enable control

- 0: Voltage monitor function is disabled,  $V_{OUT} = 0 \text{ V}$
- 1: Voltage monitor function is enabled,  $V_{OUT} = V_{BATn}/n$

Bit 4~3 Reserved bits

Bit 2~0 **B2~B0**: 8-to-1 analog multiplexer selection bits (MSB: B2, LSB: B0) Control B2~B0 to select which accumulative cell voltage to be output to VOUT.

EN_S	B2	B1	В0	V <sub>OUT</sub> (V)
0	_	_	_	0
1	0	0	0	V <sub>BAT1</sub> × 1/1
1	0	0	1	V <sub>BAT2</sub> × 1/2
1	0	1	0	V <sub>BAT3</sub> × 1/3
1	0	1	1	V <sub>BAT4</sub> × 1/4
1	1	0	0	V <sub>BAT5</sub> × 1/5
1	1	0	1	V <sub>BAT6</sub> × 1/6
1	1	1	0	V <sub>BAT7</sub> × 1/7
1	1	1	1	V <sub>BAT8</sub> × 1/8



### • Charge Balance Register

Bit	7	6	5	4	3	2	1	0
Name	CB8	CB7	CB6	CB5	CB4	CB3	CB2	CB1
R/W	R/W	R/W	R/W	R/W	R/W	R/W	R/W	R/W
POR	0	0	0	0	0	0	0	0

PUR	U	U	U		U		U	U		U		U
Bit 7	0: Ba	nable control lance switch	h OFF	charge	balanc	ce sw	vitch be	etween	VBA	AT8 and	VBA	.Т7
Bit 6	0: Ba	nable contro lance switch lance switch	h OFF	harge	balanc	ee sw	itch be	etween	VBA	T7 and	VBA	.Т6
Bit 5	0: Ba	nable control lance switch lance switch	h OFF	harge	balanc	ce sv	vitch be	etween	VBA	AT6 and	VBA	.T5
Bit 4	0: Ba	nable control lance switch	h OFF	harge	balanc	ce sw	vitch be	etween	VBA	AT5 and	VBA	.T4
Bit 3	0: Ba	nable control lance switch	h OFF	harge	baland	ce sw	vitch be	etween	VBA	AT4 and	VBA'	Т3
Bit 2	0: Ba	nable control lance switch	h OFF	harge	balanc	ce sw	vitch be	etween	VBA	AT3 and	VBA	Т2
Bit 1	0: Ba	nable control lance switch	h OFF	harge	balanc	e sw	vitch be	etween	VBA	AT2 and	VBA	.T1
Bit 0	<b>CB1</b> : E	nable control	ol of the c	harge	balanc	e sw	itch be	etween	VBA	T1 and	GND	)

## **Accumulative Cell Voltage Monitor Functional Description**

1: Balance switch ON

The accumulative cell voltage monitor consists of high voltage switches, voltage dividers and an 8-to-1 analog multiplexer as shown in the following diagram. The high voltage switches are implemented using an anti-reverse current topology which provides isolation between the output voltage and the unselected VBATn.

EN\_S, B2, B1 and B0 are four control bits from  $I^2C$  interface and are used to control the P-type MOSFET S1  $\sim$  S8 only if EN\_S = "1". The control truth table is shown below. This produces an accumulative cell voltage,  $V_{BATn}$ , divided by "n" on VOUT. This accurate  $\pm 0.5\%$  voltage divided ratio is designed to minimize any mismatch errors.



 $V_{BAT8} \times 1/8$ 

EN_S	B2	B1	В0	S8	S7	S6	S5	S4	S3	S2	S1	V <sub>OUT</sub> (V)
0	Χ	Χ	Χ	1	1	1	1	1	1	1	1	0
1	0	0	0	1	1	1	1	1	1	1	0	V <sub>BAT1</sub> × 1/1
1	0	0	1	1	1	1	1	1	1	0	1	V <sub>BAT2</sub> × 1/2
1	0	1	0	1	1	1	1	1	0	1	1	V <sub>BAT3</sub> × 1/3
1	0	1	1	1	1	1	1	0	1	1	1	V <sub>BAT4</sub> × 1/4
1	1	0	0	1	1	1	0	1	1	1	1	V <sub>BAT5</sub> × 1/5
1	1	0	1	1	1	0	1	1	1	1	1	V <sub>BAT6</sub> × 1/6
1	1	1	0	1	0	1	1	1	1	1	1	V <sub>BAT7</sub> × 1/7

**Table 3. Accumulative Cell Voltage Monitor Truth Table** 

0

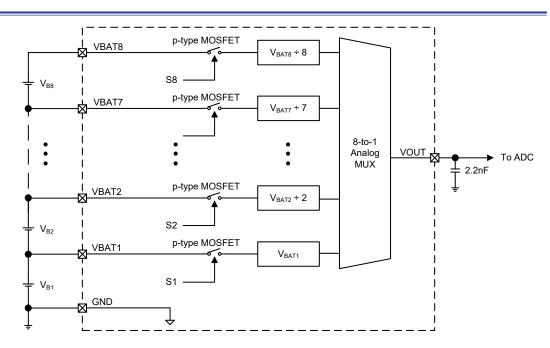


Figure 12. Accumulative Cell Voltage Monitor Functional Block

## **Charge Balance Functional Description**

Multiple channels of charge balance switch can be turned on by MCU via  $I^2C$  interface. The register address of charge balance function is 01H, and the Bit  $7 \sim Bit\ 0$  of Data byte correspond to the charge balance switch of each channel from CB8 to CB1, respectively. More than one switch can be turned on at the same time, but side-by-side cell balancing switches are recommended not to be turned on simultaneously to ensure equal balance current between each channel. After receiving a turn on command, the charge balance switch remains turned on until it is turned off by a "0" data or getting a command of SLP bit = "1". The typical charge balance current is 10mA when the battery cell voltage is  $4.2\ V$  and the external series resistance is  $100\ \Omega$ , and the balance current can be adjusted by series resistors  $R1 \sim R8$ . Note that for the reason of keeping voltage monitor accuracy, do not proceed voltage monitor while charge balance is activated.



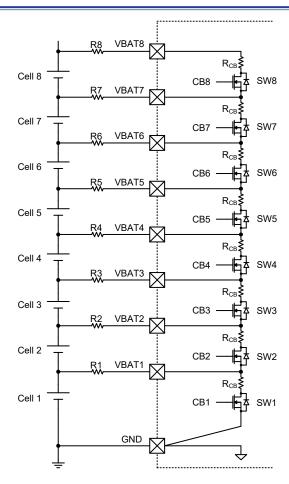


Figure 13. Charge Balance Functional Circuit Diagram

Table 4. Balance Switch ON/OFF

CB1	CB2	CB3	CB4	CB5	CB6	CB7	CB8	Balance Switch ON/OFF
1	0	0	0	0	0	0	0	SW1 ON, others OFF
0	1	0	0	0	0	0	0	SW2 ON, others OFF
0	0	1	0	0	0	0	0	SW3 ON, others OFF
0	0	0	1	0	0	0	0	SW4 ON, others OFF
0	0	0	0	1	0	0	0	SW5 ON, others OFF
0	0	0	0	0	1	0	0	SW6 ON, others OFF
0	0	0	0	0	0	1	0	SW7 ON, others OFF
0	0	0	0	0	0	0	1	SW8 ON, others OFF

Note: More than one switch can be turned on in the same time.



### **Discharge N-type MOSFET Gate-drive Functional Description**

Two discharge NMOS gate-drivers DGN0 and DGN1 are fabricated in the Accumulative Cell Voltage Monitor as discharge switch controllers. The output voltage of DGN0 and DGN1 are both clamped at 12 V. A 430 k $\Omega$  pull-down resistor is integrated in the discharge gate control input pins DN0 and DN1. The gate-driver capability of DGN0 is better than that of DGN1, therefore it is recommended to apply DGN0 on primary loading path and DGN1 on secondary loading path. While operating in the Standby or Sleep mode, the DGN0 and DGN1 are pulled down by 5  $\Omega$  and 8.5  $\Omega$  respectively. The control logic and output status of DGN0 and DGN1 in each state are listed in the following table.

Table 5. DGN0 Control Logic and Output Status

SLP	DN0	V(DGN0, GND)	Note	
0	Floating	0	Dulled leve to CND by 5.0	
0	0	0	Pulled low to GND by 5 Ω.	
0	1	Vz	Normal operation.	
1	Floating	0	Dullad law to CND by 5 O	
1	0	0	Pulled low to GND by 5 Ω.	

Table 6. DGN1 Control Logic and Output Status

SLP	DN1	V(DGN1, GND)	Note	
0	Floating	0	Pulled low to GND by 8.5 $\Omega$ .	
0	0	0		
0	1	V <sub>z</sub>	Normal operation.	
1	Floating	0	Dullad law to CND by 9.5.0	
1	0	0	Pulled low to GND by 8.5 Ω.	

## **Charge N-type MOSFET Gate-drive Functional Description**

A charge NMOS gate-driver DGCN is provided as a charge switch controller. A charge pump circuit is fabricated to provide 12 V between the gate and source node of charge NMOS. A 430 k $\Omega$  pull-down resistor is integrated in the control input pin DCN. The control logic of DCN and output status of DGCN and DSCN in each state are listed in the following table.

Table 7. DCN Control Logic, DGCN and DSCN Output Status

SLP	DCN	V(DGCN, DSCN)	Note	
0	Floating	0	DGCN and DSCN pulled low to GND by $50 \Omega$ respectively.	
0	0	0	DGCN pulled low to DSCN by 90 $\Omega$ .	
0	1	Vz	Normal operation.	
1	Floating	0	DGCN and DSCN pulled low to GND by 830 $\Omega$ respective	
1	0	0	DGCN pulled low to DSCN by 1.65 kΩ.	



### **Sleep Mode Functional Description**

It is important not to confuse this Sleep mode with the Sleep mode, which is described in the "Power Management – PWRCU" section of this datasheet.

EXT\_WK represents the external wake-up event status. EXT\_WK = "0" means that high voltage applied on the HVWK pin is not detected, on the contrary EXT\_WK = "1" denotes that wake-up event is happening such as charger connecting or power switch on. When receiving a sleep command from  $I^2C$  master at EXT\_WK = "0", the SLP bit is set to "1" and the Accumulative Cell Voltage Monitor enters the Sleep mode. During the Sleep mode, all outputs are shut down and the capacitor of VREG is discharged through internal discharge resistor. The pre-regulator and high voltage wake-up circuit are the only blocks that are still working in the Sleep mode and operate with an ultra-low standby current of  $0.1~\mu$ A (typical).

When EXT\_WK = "1", the SLP will be cleared to "0" and the sleep command from I<sup>2</sup>C master will be abandoned until EXT WK is cleared to "0".

Table 8. Enter / Exit Sleep Mode

EXT_WK Status	SLP Status			
0	According to I <sup>2</sup> C master command or POR default.			
1	0			

### **Wake up from Sleep Mode Functional Description**

The HVWK pin can be used for detecting charger plugged-in, switch turned on, or load connected events. When the Accumulative Cell Voltage Monitor is under the Sleep mode, if the HVWK pin is triggered by a pulse with requiring at least 5.5 V voltage and 1ms width, the output of VREG will resume and the whole Accumulative Cell Voltage Monitor is ready for normal operation. The reference timing diagram of entering the Sleep mode and waked up is listed below.

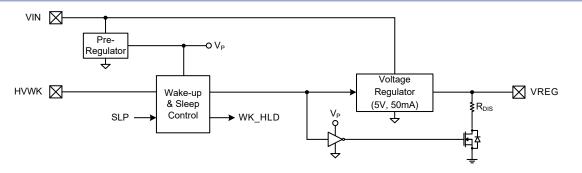


Figure 14. Wake up from Sleep Mode Functional Block Diagram



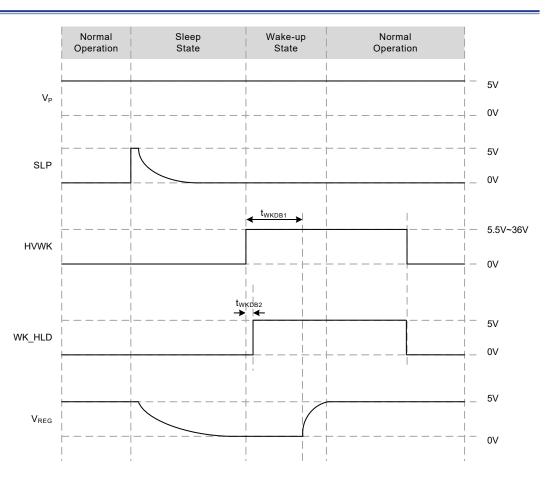


Figure 15. Entering the Sleep Mode and Waked up Reference Timing Diagram

## **Charge NMOS Switch Configuration**

Due to the internal pull down MOS switch between DSCN and GND, the recommended Charge NMOS switch configuration is back-to-back or single NMOS in series with a diode in order to avoid the DSCN pin draining current from battery.

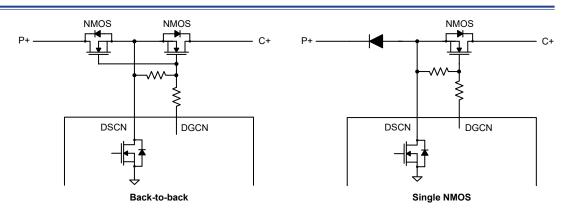


Figure 16. Charge NMOS Switch Configuration



### VIN, VREG, VOUT Capacitors

The VIN input capacitor C1 and VREG output capacitor C2 are 4.7 µF for better input noise filtering and output load transient behavior. A recommended 2.2 nF noise filtering capacitor should be connected between VOUT and GND terminals. Note that higher noise capacitance value of C3 will lower the acceptable scan frequency.



Figure 17. VIN, VREG, VOUT Capacitors Configuration

### VIN Filter Recommendation

The input capacitor C1 for VIN is used for lowering the input voltage ripple while the battery is supplying a highly inductive load in PWM mode. The recommanded value of VIN input capacitor C1 is 4.7  $\mu$ F. The input resistor R9 of VIN is able to reduce the inrush current during battery assembly, and also it shares the heat on chip while VREG outputs a large current in normal operation mode. The recommanded value for VIN input resistor R9 differs from different battery cell number applications. The recommended resistance values of VIN input resistor R9 with different battery cell numbers and the corresponding VREG maximum output current are listed in the following table.

Table 9. VIN Input Resistor R9 Recommended Resistance Values

Battery Cell Number	VIN Recommended Resistor (R9)	VREG Maximum Output Current
3 S	15 Ω	50 mA
4 S	43 Ω	50 mA
5 S	110 Ω	40 mA
6 S	220 Ω	35 mA
7 S	330 Ω	30 mA
8 S	430 Ω	30 mA



Figure 18. VIN Filter Circuit Diagram



It is necessary to select an appropriate package for VIN filter resistor (R9) in order to prevent it being damaged from overheated. The maximum power on R9 is easily calculated by:

$$P_{R9.MAX} = (I_{REG})^2 \times R9$$

where I<sub>REG</sub> is the maximum VREG output current, R9 is the resistance value of VIN filter resistor (R9).

It is recommended to choose the resistor package that its maximum rated power is greater than twice the  $P_{R9,MAX}$ .

### **VBATn Protection and Balance Resistor Selection**

The VBATn series resistors R1~R8 not only suppress inrush and noise spikes applied to I/O pins, they affect charge balance current as well. Larger resistance of R1 ~ R8 provide better protection to VBATn and other I/O pins, but they lower the charge balance current instead. The charge balance current of each channel is configured by internal balance resistance and external series resistors. Because the balance current of Cell 1 flows out through the GND pin, the balance current of Cell 1 is greater than that of other cells. Considering inrush spike protection to I/O pins and noise reduction of voltage monitor, the recommended typical values of resistor R1 ~ R8 are 100  $\Omega$ , and the charge balancing current is 11mA while the voltage of battery cell is 4.2 V. If larger balancing current is needed, the recommended minimum values of the R1 ~ R8 resistors are 30  $\Omega$  which provide 25 mA while the voltage of battery cell is 4.2 V. To ensure the internal balance circuit works properly, the minimum battery cell voltage to start the balance function is 3 V. The recommended VBATn series resistances and their related charge balancing current are listed in the following table.

Table 10. VBATn Protection and Balance Resistor Selection

Resistance of R1 ~ R8	Typical Balancing Current (@ V <sub>Bn</sub> = 4.2 V)	Note	
30 Ω	25 mA	Minimum value of resistors R1 ~ R8	
51 Ω	18 mA	_	
100 Ω	11 mA	_	
150 Ω	8.4 mA	_	

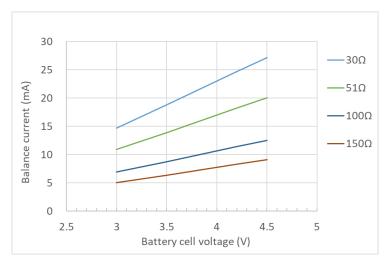


Figure 19. Balance Current VS Battery Cell Voltage



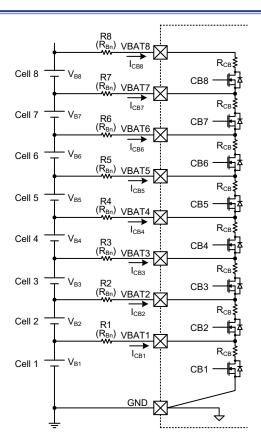


Figure 20. VBATn Protection and Charge Balance Function Circuit Diagram

## **Charger and Switch Status Detection**

The High-voltage wake-up (HVWK) function is capable of detecting charger plugged in or load switched on. The recommended HVWK external circuit is listed below. When a charger is plugged in or load switch is on, the voltage of HVWK is triggered to be larger than  $V_{WKTH}$  and set EXT\_WK bit as "1". After the charger or switch is removed or turned off, the EXT\_WK bit is reset to "0". An MCU can acquire the charger or switch status by reading the EXT\_WK bit through the  $I^2C$  interface. Therefore, by the means of reading the EXT\_WK bit status, additional charger or switch detection circuit for MCU are not necessary. The circuit below is a typical application for high-voltage wake-up function, charger plugged-in detection and charger voltage detection.



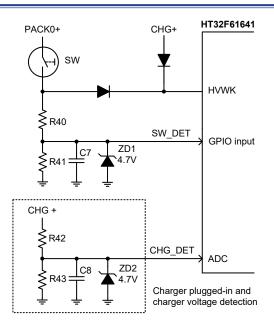


Figure 21. Charger and Switch Status Detection Circuit Diagram

## **Cell Voltage Monitor Scan Frequency**

The VOUT pin can output the accumulative cell voltage and be connected to one of the internal A/D converter channels for monitoring battery voltage status. The timing diagrams of cell voltage monitor scanning for 5S and 8S applications are shown below. The VOUT pin starts to charge the VOUT capacitor from 0V to the selected cell voltage while the EN\_S is set to "1". In order to ensure MCU A/D conversion accuracy, the A/D conversion procedure has to wait before the VOUT capacitor is fully charged. The suggested minimum waiting time is 5ms after the EN\_S is set to "1" or cell voltage monitor channel switched. It is recommended that the maximum scan frequency for accumulative cell voltage monitoring is less than 100 Hz and that  $EN_S = "0"$  when the voltage scanning procedure has finished for power saving purposes.

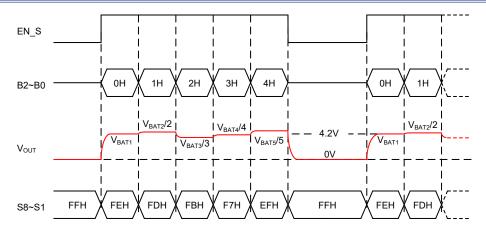


Figure 22. 5 S Battery Monitoring Timing



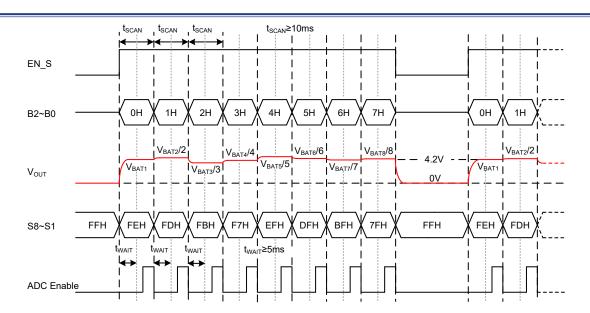


Figure 23. 8 S Battery Monitoring Timing

### **Voltage Spike Suppression Method**

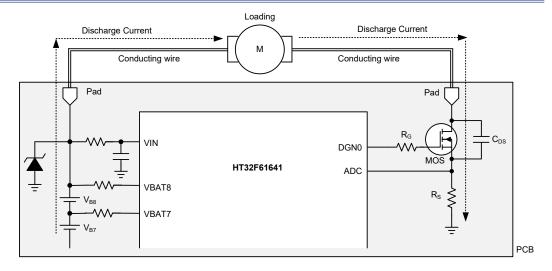


Figure 24. Simplified Typical BMS System Discharge Path Diagram

Most battery-management systems would monitor charge and discharge current to prevent overcurrent damage. Due to the parasitic inductance on conducting wires and PCB layout connections, large voltage spike may occurs while the MOS rapidly shuts down the charge or discharge current, and this spike may damage the device VBATn or VIN pins. Any voltage spike on the VBATn and VIN pins should not over the limitation in Absolute Maximum Ratings, which is 48 V. Four recommended measures listed below would help to reduce the voltage spike.



- 1. Make the external conducting wire and PCB layout connections as short as possible where large charge or discharge current flows.
- 2. Adjust the slew rate of MOS switch with the gate resistor R<sub>G</sub>. Turn off the MOS with slower slew rate for lower voltage spike, and the tradeoff is a slower protection response time.
- 3. Add a capacitor ( $C_{DS}$ ) between drain and source node of the MOS switch as shown above. The recommended capacitance is  $0.1\mu F$  to  $0.22~\mu F$ .
- 4. Add a Zener diode between the highest voltage potential node of battery cells and GND.

## **PCB Layout Considerations**

The following component placement and layout guidelines are suggested for the sake of noise reduction and voltage spike suppression.

- 1. The VIN filter capacitor must be close to VIN pin.
- 2. The VREG regulation and noise filter capacitor must be close to VREG pin.
- 3. The tracks where large current would flow through should be wide and short to suppress the voltage spike at the time when external NMOS switch change its ON / OFF state.
- 4. Minimize VBAT1 ~ VBAT8 signal trace length to reduce parasitic inductance and capacitance and improve measure accuracy.

### **Thermal Considerations**

The maximum power dissipation depends upon the thermal resistance of the IC package, PCB layout, rate of surrounding airflow and difference between the junction and ambient temperature. The maximum power dissipation can be calculated by the following formula:

$$P_{D(MAX)} = (T_{J(MAX)} - T_A) / \theta_{JA} (W)$$

where  $T_{J(MAX)}$  is the maximum junction temperature,  $T_A$  is the ambient temperature and  $\theta_{JA}$  is the junction-to-ambient thermal resistance of IC package.

For maximum operating rating conditions, the maximum junction temperature is 125 °C. However, it is recommended that the maximum junction temperature does not exceed 125 °C during normal operation to maintain high reliability. The de-rating curve of the maximum power dissipation is show below:

$$P_{D(MAX)} = (125 \, {}^{\circ}\text{C} - 25 \, {}^{\circ}\text{C}) \, / \, (50 \, {}^{\circ}\text{C/W}) = 2 \, \text{W}$$

For a fixed  $T_{J(MAX)}$  of 125 °C, the maximum power dissipation depends upon the operating ambient temperature and the package's thermal resistance,  $\theta_{JA}$ . The de-rating curve below shows the effect of rising ambient temperature on the maximum recommended power dissipation.



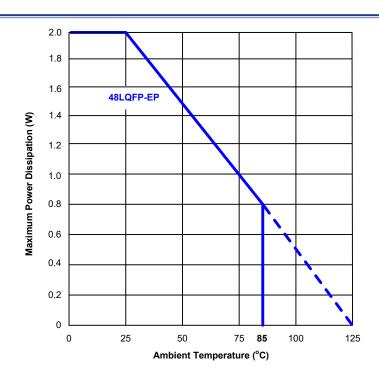


Figure 25. Maximum Power Dissipation VS Ambient Temperature



# **5** Pin Assignment

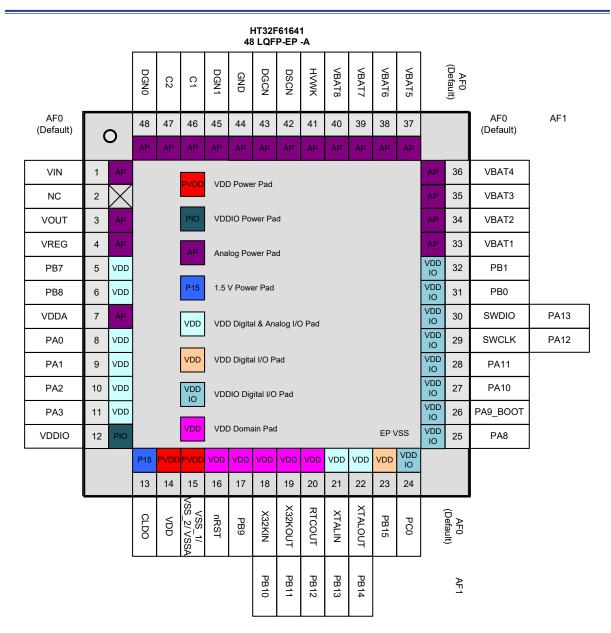


Figure 26. 48-pin LQFP-EP Pin Assignment



**Table 11. Pin Assignment** 

Packages		Alternate Function Mapping														
ackages	AF0	AF1	AF2	AF3	AF4	AF5	AF6	AF7	AF8	AF9	AF10	AF11	AF12	AF13	AF14	AF15
48 LQFP-EP	System Default	GPIO	ADC	N/A	MCTM /GPTM	SPI	USART /UART	I <sup>2</sup> C	N/A	N/A	N/A	N/A	N/A	PWM	N/A	System Other
8	PA0		ADC_ IN2		GT_ CH0	SPI1_ SCK	USR_ RTS	I2C1_ SCL								
9	PA1		ADC_ IN3		GT_ CH1	SPI1_ MOSI	USR_ CTS	I2C1_ SDA								
10	PA2		ADC_ IN4		GT_ CH2	SPI1_ MISO	USR_ TX									
11	PA3		ADC_ IN5		GT_ CH3	SPI1_ SEL	USR_ RX									
12	VDDIO															
13	CLDO															
14	VDD															
15, EP <sup>(Note)</sup>	VSS_1/ VSS_2/ VSSA															
16	nRST															
17	PB9				MT_ CH3									PWM1_ CH2		WAKEUP1
18	X32KIN	PB10			GT_ CH0	SPI1_ SEL	USR_ TX							PWM1_ CH3		
19	X32KOUT	PB11			GT_ CH1	SPI1_ SCK	USR_ RX							PWM0_ CH3		
20	RTCOUT	PB12				SPI0_ MISO	UR0_ RX							PWM0_ CH0		WAKEUP0
21	XTALIN	PB13					UR0_ TX	I2C0_ SCL								
22	XTALOUT	PB14					UR0_ RX	I2C0_ SDA								
23	PB15				MT_ CH0	SPI0_ SEL		I2C1_ SCL						PWM0_ CH1		
24	PC0				MT_ CH0N	SPI0_ SCK		I2C1_ SDA						PWM0_ CH2		
25	PA8						USR_ TX							PWM1_ CH3		
26	PA9_ BOOT					SPI0_ MOSI								PWM1_ CH0		CKOUT
27	PA10				MT_ CH1	SPI0_ MOSI	USR_ RX							PWM0_ CH1		
28	PA11				MT_ CH1N	SPI0_ MISO								PWM0_ CH2		
29	SWCLK	PA12														
30	SWDIO	PA13														
31	PB0				MT_ CH1	SPI1_ MOSI	USR_ TX	I2C0_ SCL						PWM0_ CH1		
32	PB1				MT_ CH1N	SPI1_ MISO	USR_ RX	I2C0_ SDA						PWM1_ CH1		
33	VBAT1															
34	VBAT2															
35	VBAT3															
36	VBAT4															
37	VBAT5 VBAT6															
39	VBAT7															



Daakaas							Alternate	Funct	ion Ma	apping	9					
Packages	AF0	AF1	AF2	AF3	AF4	AF5	AF6	AF7	AF8	AF9	AF10	AF11	AF12	AF13	AF14	AF15
48 LQFP-EP	System Default	GPIO	ADC	N/A	MCTM /GPTM	SPI	USART /UART	I <sup>2</sup> C	N/A	N/A	N/A	N/A	N/A	PWM	N/A	System Other
40	VBAT8															
41	HVWK															
42	DSCN															
43	DGCN															
44	GND															
45	DGN1															
46	C1															
47	C2															
48	DGN0															
1	VIN															
2	NC															
3	VOUT															
4	VREG															
5	PB7		ADC_ IN0		MT_ CH1	SPI0_ MISO	UR0_ TX	I2C1_ SCL						PWM0_ CH3		
6	PB8		ADC_ IN1		MT_ CH1N	SPI0_ SEL	UR0_ RX	I2C1_ SDA						PWM1_ CH3		
7	VDDA															

Note: The EP VSS is internally connected to the VSS pin number 15 and externally connected to the GND pin. The EP means the Exposed Pad of the LQFP-EP package.

**Table 12. Pin Description** 

Table 12.	2000				
Pin Number	Pin	Type <sup>(1)</sup>	I/O	Output	Description
48 LQFP-EP	Name	rype\*/	Structure <sup>(2)</sup>	Driving	Default Function (AF0)
8	PA0	AI/O	5V	4/8/12/16 mA	PA0
9	PA1	AI/O	5V	4/8/12/16 mA	PA1
10	PA2	AI/O	5V	4/8/12/16 mA	PA2
11	PA3	AI/O	5V	4/8/12/16 mA	PA3
12	VDDIO	Р	_	_	Voltage for digital I/O
13	CLDO	Р	_	_	Core power LDO V <sub>CORE</sub> output It must be connected a 2.2 µF capacitor as close as possible between this pin and VSS_1/VSS_2/VSSA.
14	VDD	Р	_	_	Voltage for digital I/O
15, EP	VSS_1/ VSS_2/ VSSA	Р	_	_	Ground reference for digital I/O and A/D converter
16	nRST(3)	I	5V_PU	_	External reset pin
17	PB9(3)	I/O (V <sub>DD</sub> )	5V	4/8/12/16 mA	PB9
18	PB10(3)	AI/O (V <sub>DD</sub> )	5V	4/8/12/16 mA	X32KIN
19	PB11(3)	AI/O (V <sub>DD</sub> )	5V	4/8/12/16 mA	X32KOUT
20	PB12(3)	I/O (V <sub>DD</sub> )	5V	4/8/12/16 mA	RTCOUT
21	PB13	AI/O	5V	4/8/12/16 mA	XTALIN
22	PB14	AI/O	5V	4/8/12/16 mA	XTALOUT



Pin Number	Pin	_ (0)	I/O	Output	Description
48 LQFP-EP	Name	Type <sup>(1)</sup>	Structure <sup>(2)</sup>	Driving	Default Function (AF0)
23	PB15	I/O	5V	4/8/12/16 mA	PB15
24	PC0	I/O (V <sub>DDIO</sub> )	5V	4/8/12/16 mA	PC0
25	PA8	I/O (V <sub>DDIO</sub> )	5V	4/8/12/16 mA	PA8
26	PA9	I/O (V <sub>DDIO</sub> )	5V_PU	4/8/12/16 mA	PA9_BOOT
27	PA10	I/O (V <sub>DDIO</sub> )	5V	4/8/12/16 mA	PA10
28	PA11	I/O (V <sub>DDIO</sub> )	5V	4/8/12/16 mA	PA11
29	PA12	I/O (V <sub>DDIO</sub> )	5V_PU	4/8/12/16 mA	SWCLK
30	PA13	I/O (V <sub>DDIO</sub> )	5V_PU	4/8/12/16 mA	SWDIO
31	PB0	I/O (V <sub>DDIO</sub> )	5V	4/8/12/16 mA	PB0
32	PB1	I/O (V <sub>DDIO</sub> )	5V	4/8/12/16 mA	PB1
33	VBAT1	Al	—	_	Battery cell 1 positive terminal and battery cell 2 negative terminal
34	VBAT2	Al	_	_	Battery cell 2 positive terminal and battery cell 3 negative terminal
35	VBAT3	Al	_	_	Battery cell 3 positive terminal and battery cell 4 negative terminal
36	VBAT4	Al	_	_	Battery cell 4 positive terminal and battery cell 5 negative terminal
37	VBAT5	Al	_	_	Battery cell 5 positive terminal and battery cell 6 negative terminal
38	VBAT6	Al	_	_	Battery cell 6 positive terminal and battery cell 7 negative terminal
39	VBAT7	Al	_	_	Battery cell 7 positive terminal and battery cell 8 negative terminal
40	VBAT8	Al	_		Battery cell 8 positive terminal
41	HVWK	Al	_	_	High voltage wake-up function sense and trigger pin
42	DSCN	AO	_	_	Charge pump reference voltage input. Connect to charge N-type MOSFET source pin
43	DGCN	AO	_	_	Gate-driver output for driving charge N-type MOSFET with 12 V clamped from DGCN to DSCN
44	GND	Р	_	_	Accumulative cell voltage monitor ground terminal
45	DGN1	AO	_	_	Gate-driver output 1 for driving discharge N-type MOSFET. Recommended for applying on secondary loading path
46	C1	AI	_	_	Charge pump capacitor for DGCN. Connect an capacitor between C1 and C2
47	C2	Al	_	_	Charge pump capacitor for DGCN. Connect an capacitor between C1 and C2
48	DGN0	AO	_	_	Gate-driver output 0 for driving discharge N-type MOSFET. Recommended for applying on primary loading path
1	VIN	Р	_	_	Regulator input supply voltage. Connect to the top VBATn
2	NC	_	_	_	No connected



Pin Number	Pin	<b>T</b> o (1)	I/O	Output	Description				
48 LQFP-EP	Name	Type <sup>(1)</sup>	Structure <sup>(2)</sup>	Driving	Default Function (AF0)				
3	VOUT	АО	_	_	VOUT is 8 to 1 analog multiplexer output. It is necessary to connect a 2.2 nF capacitor to GND				
4	VREG	Р	_	_	Regulator 5V/50mA output. Connect a 4.7 µF capacitor typically				
5	PB7	AI/O	5V	4/8/12/16 mA	PB7				
6	PB8	AI/O	5V	4/8/12/16 mA	PB8				
7	VDDA	Р	_	_	Analog voltage for ADC				

Note: 1. I = input, O = output, A = Analog port, P = power supply,  $V_{DD} = V_{DD}$  Power, EP = Exposed Pad.

- 2. 5V = 5 V operation I/O type, PU = Pull-up.
- 3. These pins are located at the  $V_{DD}$  power domain.

## **Internal Connection Signal Lines**

The MCU generated signals such as the GPTM channel output and MCTM channel output have been internally connected to the Accumulative Cell Voltage Monitor input for control purpose. Note that the PB2 ~ PB5 and PC1 lines, which are internally connected to the accumulative cell voltage monitor DN0, SDA, SCL, DN1 and DCN inputs respectively. These output levels are used to control the operation of the Accumulative Cell Voltage Monitor. It is necessary to ensure that the PB2 ~ PB5 and PC1 are selected as output types. The connections are listed in the following table and the related control registers should be configured correctly using application program.

**Table 13. Internal Connection Signal Lines** 

MCU Signal Name	Accumulative Cell Voltage Monitor Signal Name	Description
PC1	DCN	Gate-driver DGCN control input <sup>(Note)</sup> . The MCU AFIO setting should be AF0 to select the General Purpose Input/Output pin function.
PB5/ GT_CH2(GPTM)	DN1	Gate-driver DGN1 control input <sup>(Note)</sup> . If the GT_CH2 output is used, the MCU AFIO setting should be AF4 to select the GPTM pin function.
PB4	SCL	Accumulative cell voltage monitor I <sup>2</sup> C serial clock line. The MCU AFIO setting should be AF0 to select the General Purpose Input/Output pin function.
PB3	SDA	Accumulative cell voltage monitor I <sup>2</sup> C serial data line. The MCU AFIO setting should be AF0 to select the General Purpose Input/Output pin function.
PB2/ MT_CH2(MCTM)	DN0	Gate-driver DGN0 control input <sup>(Note)</sup> . If the MT_CH2 output is used, the MCU AFIO setting should be AF4 to select the MCTM pin function.

Note: Internal pull down with 430 k $\Omega$ .





## **Electrical Characteristics**

## **Absolute Maximum Ratings**

The following table shows the absolute maximum ratings of the device. These are stress ratings only. Stresses beyond absolute maximum ratings may cause permanent damage to the device. Note that the device is not guaranteed to operate properly at the maximum ratings. Exposure to the absolute maximum rating conditions for extended periods may affect device reliability.

**Table 14. Absolute Maximum Ratings** 

Parameter	Value	Unit
$V_{DD}$	(Vss-0.3) to (Vss+5.5)	V
$V_{\text{DDIO}}$	(Vss-0.3) to (Vss+5.5)	V
Input Voltage	(Vss-0.3) to (V <sub>DD</sub> +0.3)	V
T <sub>A</sub>	-40 to 85	°C
T <sub>STG</sub>	-60 to 150	°C
$T_J$	<125	°C
$P_D$	<500	mW
VIN, DSCN, HVWK, C2	-0.3 to 48	V
DGCN, C1	-0.3 to 60	V
DGN0, DGN1	-0.3 to 18	V
V <sub>REG</sub> , V <sub>OUT</sub> , V <sub>BAT1</sub>	-0.3 to 5.5	V
Δ [ VBATi ~ VBAT(i-1) ], i = 8 ~ 2	-0.3 to 5.5	V
Electrostatic Discharge Voltage (Human Body Model)	-2000 to 2000	V

## **Recommended DC Operating Conditions**

**Table 15. Recommended DC Operating Conditions** 

 $T_A$  = 25 °C, unless otherwise specified.

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
$V_{DD}$	Operating Voltage	_	2.5	5.0	5.5	V
$V_{\text{DDIO}}$	I/O Operating Voltage	_	1.8	5.0	5.5	V
$V_{DDA}$	Analog Operating Voltage	_	2.5	5.0	5.5	V

## **Recommended Operating Range**

Table 16. Recommended Operating Range

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
$V_{IN}$	Regulator Input Voltage	_	7.5	_	36	V
T <sub>A</sub>	Operating Temperature Range	_	-40	_	85	°C

Note: Recommended Operating Ratings indicate conditions for which the device is intended to be functional, but do not guarantee specified performance limits



## **On-Chip LDO Voltage Regulator Characteristics**

#### **Table 17. LDO Characteristics**

 $T_A = 25$  °C, unless otherwise specified.

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
$V_{LDO}$	Internal Regulator Output Voltage	$V_{DD} \ge 2.5 \text{ V}$ Regulator input @ $I_{LDO} = 35 \text{ mA}$ and voltage variant = $\pm 5$ %, After trimming	1.425	1.5	1.57	V
I <sub>LDO</sub>	Output Current	V <sub>DD</sub> = 2.5 V Regulator input @ V <sub>LDO</sub> = 1.5 V	_	30	35	mA
C <sub>LDO</sub>	External Filter Capacitor Value for Internal Core Power Supply	The capacitor value is dependent on the core power current consumption	1	2.2	_	μF

## **Power Consumption**

#### **Table 18. Power Consumption Characteristics**

 $T_A$  = 25 °C, unless otherwise specified.

			_			
Symbol	Parameter	Conditions	Тур	Max	Unit	
		$V_{DD}$ = 5.0 V, HSI = 20 MHz, $f_{CPU}$ = 20 MHz, $f_{BUS}$ = 20 MHz, all peripherals enabled	6.5	7.2		
		$V_{DD}$ = 5.0 V, HSI = 20 MHz, $f_{CPU}$ = 20 MHz, $f_{BUS}$ = 20 MHz, all peripherals disabled	4	4.5		
	Supply Current	$V_{DD}$ = 5.0 V, HSI = 20 MHz, $f_{CPU}$ = 10 MHz, $f_{BUS}$ = 10 MHz, all peripherals enabled	3.5	3.9	mA	
	(Run Mode)	$V_{DD}$ = 5.0 V, HSI = 20 MHz, $f_{CPU}$ = 10 MHz, $f_{BUS}$ = 10 MHz, all peripherals disabled	2.25	2.5		
		$V_{DD}$ = 5.0 V, HSI off, LSI on, $f_{CPU}$ = 32 kHz, $f_{BUS}$ = 32 kHz, all peripherals enabled	32 41		μΑ	
I <sub>DD</sub>		$V_{DD}$ = 5.0 V, HSI off, LSI on, $f_{CPU}$ = 32 kHz, $f_{BUS}$ = 32 kHz, all peripherals disabled	28	28 37		
		$V_{DD}$ = 5.0 V, HSI = 20 MHz, $f_{CPU}$ = 0 MHz, $f_{BUS}$ = 20 MHz, all peripherals enabled				
	Supply Current	$V_{DD}$ = 5.0 V, HSI = 20 MHz, $f_{CPU}$ = 0 MHz, $f_{BUS}$ = 20 MHz, all peripherals disabled	0.8	0.92	mA	
	(Sleep Mode)	$V_{DD}$ = 5.0 V, HSI = 20 MHz, $f_{CPU}$ = 0 MHz, $f_{BUS}$ = 10 MHz, all peripherals enabled	2	2.25	IIIA	
		$V_{DD}$ = 5.0 V, HSI = 20 MHz, $f_{CPU}$ = 0 MHz, $f_{BUS}$ = 10 MHz, all peripherals disabled	0.65	0.75		
	Supply Current (Deep-Sleep1 Mode)	V <sub>DD</sub> = 5.0 V, All clock off (HSE/HSI/LSE), LDO in low power mode, LSI on, RTC on	23	29	μΑ	
	Supply Current (Deep-Sleep2 Mode)	V <sub>DD</sub> = 5.0 V, All clock off (HSE/HSI/LSE), LDO off, DMOS on, LSI on, RTC on	6.5			

Note: 1. HSE means high speed external oscillator. HSI means 20 MHz high speed internal oscillator.

- 2. LSE means 32.768 kHz low speed external oscillator. LSI means 32 kHz low speed internal oscillator.
- 3. RTC means real-time clock.
- 4. Code = while (1) {208 NOP} executed in Flash.
- 5.  $f_{\text{BUS}}$  means  $f_{\text{HCLK}}$  and  $f_{\text{PCLK}}$ .



## **Reset and Supply Monitor Characteristics**

#### Table 19. V<sub>DD</sub> Power Reset Characteristics

 $T_A$  = 25 °C, unless otherwise specified.

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
$V_{POR}$	Power On Reset Threshold (Rising Voltage on V <sub>DD</sub> )	T₄ = -40 °C ~ 85 °C	2.22	2.35	2.48	V
$V_{PDR}$	Power Down Reset Threshold (Falling Voltage on V <sub>DD</sub> )	1 <sub>A</sub> = -40 C ~ 65 C	2.12	2.2	2.33	V
V <sub>PORHYST</sub>	POR Hysteresis	_	_	150		mV
t <sub>POR</sub>	Reset Delay Time	V <sub>DD</sub> = 5.0 V	_	0.1	0.2	ms

Note: 1. Data based on characterization results only, not tested in production.

2. If the LDO is turned on, the  $V_{DD}$  POR has to be in the de-assertion condition. When the  $V_{DD}$  POR is in the assertion state then the LDO will be turned off.

Table 20. LVD/BOD Characteristics

 $T_A$  = 25 °C, unless otherwise specified.

Symbol	Parameter	Condition	าร	Min.	Тур.	Max.	Unit
$V_{BOD}$	Voltage of Brown Out Detection	T <sub>A</sub> = -40 °C ~ 85 °C, After factory-trimmed, V	<sub>DD</sub> Falling edge	2.37	2.45	2.53	V
			LVDS = 000	2.57	2.65	2.73	V
			LVDS = 001	2.77	2.85	2.93	V
	Voltage of Low Voltage Detection	$T_A$ = -40 °C ~ 85 °C, $V_{DD}$ Falling edge	LVDS = 010	2.97	3.05	3.13	V
V			LVDS = 011	3.17	3.25	3.33	V
$V_{LVD}$			LVDS = 100	3.37	3.45	3,53	V
			LVDS = 101	4.15	4.25	4.35	V
			LVDS = 110	4.35	4.45	4.55	V
			LVDS = 111	4.55	4.65	4.75	V
V <sub>LVDHTST</sub>	LVD Hysteresis	V <sub>DD</sub> = 5.0 V		_	100	_	mV
t <sub>suLVD</sub>	LVD Setup Time	V <sub>DD</sub> = 5.0 V	_	_	_	5	μs
t <sub>atLVD</sub>	LVD Active Delay Time	V <sub>DD</sub> = 5.0 V	_	_	_	_	ms
I <sub>DDLVD</sub>	Operation Current (2)	V <sub>DD</sub> = 5.0 V	_	_	10	20	μA

Note: 1. Data based on characterization results only, not tested in production.

- 2. Bandgap current is not included.
- 3. LVDS field is in the PWRCU LVDCSR register.



#### **External Clock Characteristics**

#### Table 21. High Speed External Clock (HSE) Characteristics

 $T_A$  = 25 °C, unless otherwise specified.

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
$V_{DD}$	Operation Range	T <sub>A</sub> = -40 °C ~ 85 °C	2.5	_	5.5	V
$f_{HSE}$	High Speed External Oscillator Frequency (HSE)	V <sub>DD</sub> = 2.5 V ~ 5.0 V	4	_	20	MHz
C <sub>L</sub>	Load Capacitance	$V_{DD} = 5.0 \text{ V}, R_{ESR} = 100 \Omega @ 20 \text{ MHz}$	_	_	12	pF
R <sub>FHSE</sub>	Internal Feedback Resistor between XTALIN and XTALOUT Pins	V <sub>DD</sub> = 5.0 V		0.5	_	ΜΩ
D	Equivalent Series Resistance	V <sub>DD</sub> = 5.0 V, C <sub>L</sub> = 12 pF @ 20 MHz, HSEDR = 0		_	110	Ω
R <sub>ESR</sub>		V <sub>DD</sub> = 2.5 V, C <sub>L</sub> = 12 pF @ 20 MHz, HSEDR = 1				
D <sub>HSE</sub>	HSE Oscillator Duty Cycle	_	40	_	60	%
1	HSE Oscillator Current	$V_{DD} = 5.0 \text{ V}, R_{ESR} = 100 \Omega, C_L = 12 \text{ pF}$ @ 8 MHz, HSEDR = 0	_	0.85	_	mΛ
I <sub>DDHSE</sub>	Consumption	$V_{DD} = 5.0 \text{ V}, R_{ESR} = 25 \Omega, C_{L} = 12 \text{ pF}$ @ 20 MHz, HSEDR = 1		3.0 —		mA
I <sub>PWDHSE</sub>	HSE Oscillator Power Down Current	V <sub>DD</sub> = 5.0 V	_	_	0.01	μA
t <sub>SUHSE</sub>	HSE Oscillator Startup Time	V <sub>DD</sub> = 5.0 V	_	_	4	ms

#### Table 22. Low Speed External Clock (LSE) Characteristics

T<sub>A</sub> = 25 °C, unless otherwise specified.

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
V <sub>DD</sub>	Operation Range	T <sub>A</sub> = -40 °C ~ 85 °C	2.5	- 71	5.5	V
f <sub>CK_LSE</sub>	LSE Frequency	V <sub>DD</sub> = 2.5 V ~ 5.5 V	_	32.768	_	kHz
R <sub>F</sub>	Internal Feedback Resistor	_		10	_	ΜΩ
R <sub>ESR</sub>	Equivalent Series Resistance	V <sub>DD</sub> = 5.0 V	30	_	TBD	kΩ
C <sub>L</sub>	Recommended Load Capacitances	V <sub>DD</sub> = 5.0 V	6	_	TBD	pF
I <sub>DDLSE</sub>	Oscillator Supply Current (High current mode)	$\begin{split} f_{\text{CK\_LSE}} &= 32.768 \text{ kHz}, \\ R_{\text{ESR}} &= 50 \text{ k}\Omega, \text{ C}_{\text{L}} \geq 7 \text{ pF} \\ V_{\text{DD}} &= 2.5 \text{ V} \sim 5.5 \text{ V} \\ T_{\text{A}} &= -40 \text{ °C} \sim 85 \text{ °C} \end{split}$	_	4.0	5.6	μΑ
	Oscillator Supply Current (Low Current Mode)	$\begin{split} f_{\text{CK\_LSE}} &= 32.768 \text{ kHz}, \\ R_{\text{ESR}} &= 50 \text{ k}\Omega, \text{ C}_{\text{L}} < 7 \text{ pF} \\ V_{\text{DD}} &= 2.5 \text{ V} \sim 5.5 \text{ V} \\ T_{\text{A}} &= -40 \text{ °C} \sim 85 \text{ °C} \end{split}$	_	3.6	4.5	μA
	Power Down Current	_	_	_	0.01	μA
t <sub>SULSE</sub>	Startup Time (Low Current Mode)	$f_{CK\_LSI} = 32.768 \text{ kHz},$ $V_{DD} = 2.5 \text{ V} \sim 5.5 \text{ V}$	500	_	_	ms

Note: The following guidelines are recommended to increase the stability of the crystal circuit of the HSE / LSE clock in the PCB layout:

- 1. The crystal oscillator should be located as close as possible to the MCU to keep the trace lengths as short as possible to reduce any parasitic capacitance.
- 2. Shield lines in the vicinity of the crystal by using a ground plane to isolate signals and reduce noise.
- 3. Keep any high frequency signal lines away from the crystal area to prevent any crosstalk adverse effects.



## **Internal Clock Characteristics**

## Table 23. High Speed Internal Clock (HSI) Characteristics

 $T_A$  = 25 °C, unless otherwise specified.

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
$V_{DD}$	Operation Range	T <sub>A</sub> = -40 °C ~ 85 °C	2.5		5.5	V
f <sub>HSI</sub>	HSI Frequency	V <sub>DD</sub> = 5 V @ 25 °C	_	20	_	MHz
Δ(:(::::::::::::::::::::::::::::::::::	Factory Calibrated USI Oscillator	V <sub>DD</sub> = 5.0 V, T <sub>A</sub> = 25 °C	-2	_	2	%
	Factory Calibrated HSI Oscillator Frequency Accuracy	V <sub>DD</sub> = 2.5 V ~ 5.5 V T <sub>A</sub> = -40 °C ~ 85 °C	-3	_	3	%
Duty	Duty Cycle	f <sub>HSI</sub> = 20 MHz	35	_	65	%
	Oscillator Supply Current	f <sub>HSI</sub> = 20 MHz @	_	_	140	μA
I <sub>DDHSI</sub>	Power Down Current	$V_{DD} = 2.5 \text{ V} \sim 5.5 \text{ V}$	_	_	0.01	μA
T <sub>SUHSI</sub>	HSI Oscillator Startup time	f <sub>HSI</sub> = 20 MHz	_	_	20	μs

#### Table 24. Low Speed Internal Clock (LSI) Characteristics

 $T_A$  = 25 °C, unless otherwise specified.

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
$V_{DD}$	Operation Range	T <sub>A</sub> = -40 °C ~ 85 °C	2.5	_	5.5	V
f <sub>LSI</sub>	Low Speed Internal Oscillator Frequency (LSI)	V <sub>DD</sub> = 5.0 V, T <sub>A</sub> = -40 °C ~ 85 °C	21	32	43	kHz
ACC <sub>LSI</sub>	LSI Frequency Accuracy	V <sub>DD</sub> = 5.0 V, with factory-trimmed	-10	_	+10	%
I <sub>DDLSI</sub>	LSI Oscillator Operating Current	V <sub>DD</sub> = 5.0 V	_	0.5	0.8	μA
t <sub>SULSI</sub>	LSI Oscillator Startup Time	$V_{DD} = 5.0 \text{ V}$	_	_	100	μs

## **Memory Characteristics**

### **Table 25. Flash Memory Characteristics**

 $T_A$  = 25 °C, unless otherwise specified.

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
N <sub>ENDU</sub>	Number of Guaranteed Program / Erase Cycles before failure (Endurance)	T <sub>A</sub> = -40 °C ~ 85 °C	10	_	_	K cycles
t <sub>RET</sub>	Data Retention Time	T <sub>A</sub> = -40 °C ~ 85 °C	10	_	_	Years
t <sub>PROG</sub>	Word Programming Time	T <sub>A</sub> = -40 °C ~ 85 °C	20			μs
t <sub>ERASE</sub>	Page Erase Time	T <sub>A</sub> = -40 °C ~ 85 °C	2			ms
t <sub>MERASE</sub>	Mass Erase Time	T <sub>A</sub> = -40 °C ~ 85 °C	10	_	_	ms



## **I/O Port Characteristics**

#### Table 26. I/O Port Characteristics

 $T_A$  = 25 °C, unless otherwise specified.

Ours le al	Donomorton						
Symbol	Parameter		Conditions	Min.	Тур.	_	Unit
$I_{IL}$	Low Level Input Current	5.0 V I/O	V <sub>I</sub> = V <sub>SS</sub> , On-chip pull-up		_		μA
		Reset pin	resister disabled	_	_	3	μA
I <sub>IH</sub>	High Level Input Current	5.0 V I/O	$V_I = V_{DD}$ , On-chip		_	3	μA
-111	у до то	Reset pin	pull-down resister disabled	_	_	3	μA
$V_{IL}$	Low Level Input Voltage	5.0 V I/O		-0.5	_	V <sub>DD</sub> × 0.35	V
V IL	Low Level input voltage	Reset pin		-0.5	_	V <sub>DD</sub> × 0.35	V
	High Land In and Valle an	5.0 V I/O		V <sub>DD</sub> × 0.65	_	V <sub>DD</sub> + 0.5	V
$V_{IH}$	High Level Input Voltage	Reset pin		V <sub>DD</sub> × 0.65	_	V <sub>DD</sub> + 0.5	V
\/	Schmitt Trigger Input	5.0 V I/O			0.12 × V <sub>DD</sub>	3 3 3 3 V <sub>DD</sub> × 0.35 V <sub>DD</sub> + 0.5 V <sub>DD</sub> + 0.5  × —	mV
V <sub>HYS</sub>	Voltage Hysteresis	Reset pin		_	0.12 ×	_	mV
		5.0 V I/O 4 m	A drive, $V_{OL} = 0.6 \text{ V}$	4	_	_	mA
1	Low Level Output Current	5.0 V I/O 8 m	A drive, $V_{OL} = 0.6 \text{ V}$	8	_	_	mA
I <sub>OL</sub>	(GPIO Sink Current)	5.0 V I/O 12 i	mA drive, $V_{OL} = 0.6 V$	12	_	_	mA
		5.0 V I/O 16 i	mA drive, $V_{OL}$ = 0.6 V	16	_	_	mA
		5.0 V I/O 4 m V <sub>OH</sub> = V <sub>DD</sub> - 0.		_	4	_	mA
	High Level Output Current	5.0 V I/O 8 m V <sub>OH</sub> = V <sub>DD</sub> - 0.		_	8	_	mA
I <sub>OH</sub>	(GPIO Source Current)	5.0 V I/O 12 I V <sub>OH</sub> = V <sub>DD</sub> - 0.		_	12	_	mA
		5.0 V I/O 16 I V <sub>OH</sub> = V <sub>DD</sub> - 0.		_	16	_	mA
		5.0 V 4 mA d	rive I/O, I <sub>OL</sub> = 4 mA	_	_	0.6	V
		5.0 V 8 mA d	rive I/O, I <sub>OL</sub> = 8 mA	_	_	0.6	V
$V_{OL}$	Low Level Output Voltage	5.0 V 12 mA	drive I/O, I <sub>OL</sub> = 12 mA	_	_	0.6	V
		5.0 V 16 mA	drive I/O, I <sub>OL</sub> = 16 mA	_	_	0.6	V
		5.0 V 4 mA d	rive I/O, I <sub>OH</sub> = 4 mA	V <sub>DD</sub> - 0.6	_	_	V
		5.0 V 8 mA d	rive I/O, I <sub>OH</sub> = 8 mA	V <sub>DD</sub> - 0.6	_	_	V
V <sub>OH</sub>	-	5.0 V 12 mA	drive I/O, I <sub>OH</sub> = 12 mA	V <sub>DD</sub> - 0.6	_	_	V
		5.0 V 16 mA	drive I/O, I <sub>OH</sub> = 16 mA	V <sub>DD</sub> - 0.6	_	_	V
В	Internal Dull un Desisten	$V_{DD} = 5.0 \text{ V}$		_	50	_	kΩ
R <sub>PU</sub>	Internal Pull-up Resistor	$V_{DD} = 3.3 \text{ V}$		_	76	_	kΩ



Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
R <sub>PD</sub> Internal Pull-down Resistor	$V_{DD} = 5.0 \text{ V}$	_	50	_	kΩ	
$R_{PD}$	internal Full-down Resistor	$V_{DD} = 3.3 \text{ V}$	_	76	_	kΩ

### **ADC Characteristics**

#### **Table 27. ADC Characteristics**

T<sub>A</sub> = 25 °C, unless otherwise specified.

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
$V_{DDA}$	Operating Voltage	_	2.5	5.0	5.5	V
V <sub>ADCIN</sub>	A/D Converter Input Voltage Range	_	0	_	V <sub>REF+</sub>	V
$V_{REF}$	A/D Converter Reference Voltage	_	_	$V_{DDA}$	$V_{DDA}$	V
I <sub>ADC</sub>	Current Consumption	V <sub>DDA</sub> = 5.0 V	_	1.4	1.5	mA
I <sub>ADC_DN</sub>	Power Down Current Consumption	V <sub>DDA</sub> = 5.0 V	_	_	0.1	μA
f <sub>ADC</sub>	A/D Converter Clock Frequency	_	0.7	_	16	MHz
fs	Sampling Rate	_	0.05	_	1	Msps
t <sub>DL</sub>	Data Latency	_	_	12.5	_	1/f <sub>ADC</sub> Cycles
t <sub>s&amp;H</sub>	Sampling & Hold Time	_	_	3.5	_	1/f <sub>ADC</sub> Cycles
t <sub>ADCCONV</sub>	A/D Converter Conversion Time	_	_	16	_	1/f <sub>ADC</sub> Cycles
R <sub>I</sub>	Input Sampling Switch Resistance	_	_	_	1	kΩ
Cı	Input Sampling Capacitance	No pin/pad capacitance included	_	4	_	pF
t <sub>SU</sub>	Startup Time	_	_	_	1	μs
N	Resolution	_	_	12	_	bits
INL	Integral Non-linearity Error	$f_S = 750 \text{ ksps}, V_{DDA} = 5.0 \text{ V}$	_	±2	±5	LSB
DNL	Differential Non-linearity Error	$f_S = 750 \text{ ksps}, V_{DDA} = 5.0 \text{ V}$	_	±1	_	LSB
Eo	Offset Error	_	_	_	±10	LSB
E <sub>G</sub>	Gain Error	_	_	—	±10	LSB

Note: 1. Data based on characterization results only, not tested in production.

- 2. Due to the A/D Converter input channel and GPIO pin-shared function design limitation, the V<sub>DDA</sub> supply power of the A/D Converter has to be equal to the V<sub>DD</sub> supply power of the MCU in the application circuit.
- 3. The figure below shows the equivalent circuit of the A/D Converter Sample-and-Hold input stage where  $C_l$  is the storage capacitor,  $R_l$  is the resistance of the sampling switch and  $R_S$  is the output impedance of the signal source  $V_S$ . Normally the sampling phase duration is approximately,  $3.5/f_{ADC}$ . The capacitance,  $C_l$ , must be charged within this time frame and it must be ensured that the voltage at its terminals becomes sufficiently close to  $V_S$  for accuracy. To guarantee this,  $R_S$  is not allowed to have an arbitrarily large value.



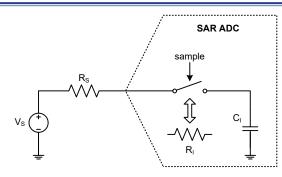


Figure 27. ADC Sampling Network Model

The worst case occurs when the extremities of the input range (0 V and  $V_{REF}$ ) are sampled consecutively. In this situation a sampling error below 1/4 LSB is ensured by using the following equation:

$$R_{S} \leq \frac{3.5}{f_{ADC}C_{I}ln(2^{N+2})} - R_{I}$$

Where  $f_{ADC}$  is the ADC clock frequency and N is the ADC resolution (N = 12 in this case). A safe margin should be considered due to the pin/pad parasitic capacitances, which are not accounted for in this simple model.

If, in a system where the A/D Converter is used, there are no rail-to-rail input voltage variations between consecutive sampling phases,  $R_{\rm S}$  may be larger than the value indicated by the equation above.

#### MCTM/GPTM/PWM Characteristics

Table 28. MCTM/GPTM/PWM Characteristics

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
f <sub>TM</sub>	Timer Clock Source for MCTM, GPTM and PWM	_			f <sub>PCLK</sub>	MHz
t <sub>RES</sub>	Timer Resolution Time	_	1	_	_	f <sub>TM</sub>
$f_{EXT}$	External Single Frequency on Channel 1 ~ 4	_	_	_	1/2	$f_{TM}$
RES	Timer Resolution	_			16	bits

## **Accumulative Cell Voltage Monitor Electrical Characteristics**

**Table 29. Accumulative Cell Voltage Monitor Electrical Characteristics** 

 $V_{IN}$  = 36 V,  $C_{VREG}$  = 4.7  $\mu$ F,  $C_{VOUT}$  = 2.2 nF,  $T_A$  = 25 °C, unless otherwise specified

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
Supply an	d Input					
V <sub>IN</sub>	Supply Voltage	_	7.5	_	36.0	V
I <sub>IN(VM_ACT)</sub>	Supply Current When Voltage Monitor is Activated	EN_S = 1	6	11	16	μA
I <sub>IN(STB)</sub>	Supply Current – Standby	$B2 = B1 = B0 = EN_S = 0,$ $V_{DN0} = V_{DN1} = V_{DCN} = 0 V$	_	3.5	6.0	μA



Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
I <sub>IN(STB_DSG)</sub>	VIN Supply Current When DGN0 is Activated	B2 = B1 = B0 = EN_S = 0, V <sub>DN0</sub> = 5 V, V <sub>DN1</sub> = V <sub>DCN</sub> = 0 V	_	35	42	μA
I <sub>SLP</sub>	Standby Current in SLEEP Mode	V <sub>SLP</sub> = 5 V, V <sub>HVWK</sub> = 0 V	_	0.1	0.2	μA
Voltage Re	gulator					
$V_{REG}$	Regulator Output Voltage	I <sub>LOAD</sub> = 10 mA	4.95	5.00	5.05	V
I <sub>REG</sub>	Regulator Maximum Output Current	V <sub>IN</sub> = 7.5 V, T <sub>A</sub> = -40 °C ~ 85 °C	50	_	_	mA
$\Delta V_{REG}$	Load Regulation	I <sub>LOAD</sub> = 0 mA ~ 50 mA	_	30	80	mV
$\Delta V_{REG}/$ $(V_{REG} \times \Delta V_{IN})$	Line Regulation	V <sub>IN</sub> = 7.5 V ~ 36 V, I <sub>LOAD</sub> = 10 mA	_	0.02	_	%/V
$\Delta V_{REG}/$ $(V_{REG} \times \Delta T_A)$	Temperature Coefficient	I <sub>LOAD</sub> = 1 mA, T <sub>A</sub> = -40 °C ~ 85 °C	_	±100	_	ppm /°C
R <sub>DIS</sub>	VREG Discharge Resistance	SLP = 1, $V_{REG}$ = 1 V, $I_{REG1}$ denotes VREG input current at $V_{REG}$ = 1 V, $R_{DIS}$ = $V_{REG}/I_{REG1}$	_	85	_	Ω
Charge Ba	lancer					
D	Charge Balance Besistance	$V_{Bi}$ = 4.5 V (i = 1 ~ 8), VBATn series resistors = 0 $\Omega$	55	85	115	Ω
R <sub>CB</sub>	Charge Balance Resistance	$V_{Bi}$ = 2.5 V (i = 1 ~ 8), VBATn series resistors = 0 $\Omega$	80	120	160	Ω
High Volta	ge Wake-Up					
$V_{\text{WKTH}}$	HVWK Trigger Threshold Voltage	_	4.5	5.5	6.5	V
t <sub>WKDB1</sub>	HVWK Trigger Debounce Time	_	1	_	_	ms
I <sub>wk</sub>	HVWK Input Current	V <sub>HVWK</sub> = 36 V		50	_	μA
Accumulat	tive Cell Voltage Monitor					
$V_{Bi}$	Cell Voltage	i = 1 ~ 8	2.5	_	4.5	V
$V_{\text{B(MIN)}}$	Input Voltage between VBATi and VBAT(i-1) for Charge Balance and Voltage Monitor	_	1.5	_	_	V
I <sub>Bi(PWR)</sub>	Cell Input Leakage Current When V <sub>IN</sub> is Powered	$V_{BATi} = 5 \text{ V} \times i$ , EN_S = 0, $V_{IN} = V_{BAT8}$ , $i = 1 \sim 8$	-0.1	_	0.1	μA
I <sub>Bi(ACT)</sub>	Cell Input Current When Voltage Monitoring	$V_{Bi} = 4.5 \text{ V}, \text{ EN\_S} = 1, V_{IN} = 36 \text{ V},$ $i = 1 \sim 8$	19	24	35	μA
R	Divided Resistance	_	140	200	260	kΩ
Patio 9	VBAT8 Accumulative Cell	V <sub>BAT8</sub> = 20 V ~ 36 V, B2 ~ B0 = 0b111	0.995	1	1.005	V/V
Ratio8 <sub>(NORM)</sub>	Voltage Divided Ratio (Normalized)	V <sub>BAT8</sub> = 20 V ~ 36 V, B2 ~ B0 = 0b111, T <sub>A</sub> = -40 °C ~ 85 °C	0.99	1	1.01	V/V



Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
Potio7	VBAT7 Accumulative Cell	V <sub>BAT7</sub> = 17.5 V ~ 31.5 V, B2 ~ B0 = 0b110	0.995	1	1.005	V/V
Ratio7 <sub>(NORM)</sub>	Voltage Divided Ratio (Normalized)	V <sub>BAT7</sub> = 17.5 V ~ 31.5 V, B2 ~ B0 = 0b110, T <sub>A</sub> = -40 °C ~ 85 °C	0.99	1	1.01	V/V
Detico	VBAT6 Accumulative Cell	V <sub>BAT6</sub> = 15 V ~ 27 V, B2 ~ B0 = 0b101	0.995	1	1.005	V/V
Ratio6 <sub>(NORM)</sub>	Voltage Divided Ratio (Normalized)	V <sub>BAT6</sub> = 15 V ~ 27 V, B2 ~ B0 = 0b101, T <sub>A</sub> = -40 °C ~ 85 °C	0.99	1	1.01	V/V
Potio	VBAT5 Accumulative Cell Voltage Divided Ratio	V <sub>BAT5</sub> = 12.5 V ~ 22.5 V, B2 ~ B0 = 0b100	0.995	1	1.005	V/V
Ratio5 <sub>(NORM)</sub>	(Normalized)	V <sub>BAT5</sub> = 12.5 V ~ 22.5 V, B2 ~ B0 = 0b100, T <sub>A</sub> = -40 °C ~ 85 °C	0.99	1	1.01	V/V
Dotio 4	VBAT4 Accumulative Cell	V <sub>BAT4</sub> = 10 V ~ 18 V, B2 ~ B0 = 0b011	0.995	1	1.005	V/V
Ratio4 <sub>(NORM)</sub>	Voltage Divided Ratio (Normalized)	V <sub>BAT4</sub> = 10 V ~ 18 V, B2 ~ B0 = 0b011, T <sub>A</sub> = -40 °C ~ 85 °C	0.99	1	1.01	V/V
Detico	VBAT3 Accumulative Cell	V <sub>BAT3</sub> = 7.5 V ~ 13.5 V, B2 ~ B0 = 0b010	0.995	1	1.005	V/V
Ratio3 <sub>(NORM)</sub>	Voltage Divided Ratio (Normalized)	V <sub>BAT3</sub> = 7.5 V ~ 13.5 V, B2 ~ B0 = 0b010, T <sub>A</sub> = -40 °C ~ 85 °C	0.99	1	1.01	V/V
	VBAT2 Accumulative Cell	V <sub>BAT2</sub> = 5 V ~ 9 V, B2 ~ B0 = 0b001	0.995	1	1.005	V/V
Ratio2 <sub>(NORM)</sub>	Voltage Divided Ratio (Normalized)	$V_{BAT2} = 5 \text{ V} \sim 9 \text{ V}, B2 \sim B0 = 0b001,}$ $T_A = -40 \text{ °C} \sim 85 \text{ °C}$	0.99	1	1.01	V/V
Detied	VBAT1 Accumulative Cell $V_{BAT1} = 2.5 \text{ V} \sim 4.5 \text{ V},$ $B2 \sim B0 = 0b000$		0.995	1	1.005	V/V
Ratio1 <sub>(NORM)</sub>	Voltage Divided Ratio (Normalized)	V <sub>BAT1</sub> = 2.5 V ~ 4.5 V, B2 ~ B0 = 0b000, T <sub>A</sub> = -40 °C ~ 85 °C	0.99	1	1.01	V/V
f <sub>MAX</sub>	Voltage Monitor Channel to Channel Scan Frequency	C <sub>VOUT</sub> = 2.2 nF	_	_	100	Hz
Gate-drive	rs					
		$V_{DN0} = V_{DN1} = 5 \text{ V}, V_{IN} > 13 \text{ V}$	10	12	16	V
V	DGNx Clamp Voltage	V <sub>DN0</sub> = V <sub>DN1</sub> = 5 V, V <sub>IN</sub> ≤ 13 V	_	V <sub>IN</sub> - 0.7	_	V
$V_Z$		V <sub>DCN</sub> = 5 V, V <sub>IN</sub> > 15 V	10	12	16	V
	V(DGCN,DSCN) Clamp Voltage	V <sub>DCN</sub> = 5 V, V <sub>IN</sub> ≤ 15 V	_	V <sub>IN</sub> - 3.2	_	V
t <sub>r0</sub>	DGN0 Rising Time	C <sub>DGN0</sub> = 15 nF	_	0.5	1.0	μs
t <sub>f0</sub>	DGN0 Falling Time	C <sub>DGN0</sub> = 15 nF	_	0.5	1.0	μs
t <sub>PD_HL0</sub>	DGN0 Falling Propagation Delay Time	C <sub>DGN0</sub> = 15 nF	_	0.5	1.0	μs
t <sub>MM0</sub>	DGN0 Delay Time Mismatch	$C_{DGN0} = 15 \text{ nF},$ $t_{MM0} =  t_{PD\_LH0} - t_{PD\_HL0} $	_	0.5	1.0	μs
I <sub>SOURCE0</sub>	DGN0 Source Current	$C_{DGN0}$ = 1 $\mu F$ , peak current at DN0 rising edge (0 $\rightarrow$ 1)	_	850	_	mA
I <sub>SINK0</sub>	DGN0 Sink Current	$C_{DGN0}$ = 1 $\mu$ F, peak current at DN0 falling edge (1 $\rightarrow$ 0)	_	400	_	mA



Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
f <sub>PWM0</sub>	DGN0 PWM Frequency	C <sub>DGN0</sub> = 15 nF	_	_	10	kHz
t <sub>r1</sub>	DGN1 Rising Time	C <sub>DGN1</sub> = 15 nF	_	1.2	2.5	μs
t <sub>f1</sub>	DGN1 Falling Time	C <sub>DGN1</sub> = 15 nF		1.2	2.5	μs
t <sub>PD_HL1</sub>	DGN1 Falling Propagation Delay Time	C <sub>DGN1</sub> =15 nF	_	1.2	2.5	μs
t <sub>MM1</sub>	DGN1 Delay Time Mismatch	$C_{DGN1} = 15 \text{ nF},$ $t_{MM1} =  t_{PD\_LH1} - t_{PD\_HL1} $	_	1.2	2.5	μs
I <sub>SOURCE1</sub>	DGN1 Source Current	$C_{DGN1}$ = 1 $\mu$ F, peak current at DN1 rising edge (0 $\rightarrow$ 1)	_	350	_	mA
I <sub>SINK1</sub>	DGN1 Sink Current	$C_{DGN1}$ = 1 $\mu F$ , peak current at DN1 falling edge (1 $\rightarrow$ 0)	_	180	_	mA
f <sub>PWM1</sub>	DGN1 PWM Frequency	C <sub>DGN1</sub> = 15 nF	_	_	2	kHz
$f_{CP}$	Charge Pump Switching Frequency	External capacitor is 22 nF between C1 and C2	_	150	_	kHz
$t_{rC}$	Rising Time of The Voltage Difference between DGCN and DSCN	C <sub>DGCN-DSCN</sub> = 15 nF, V <sub>IN</sub> = 36 V	_	500	_	μs
t <sub>fC</sub>	Falling Time of The Voltage Difference between DGCN and DSCN	C <sub>DGCN-DSCN</sub> = 15 nF, V <sub>IN</sub> = 36 V	_	5	10	μs
R <sub>PD</sub>	DN0, DN1, DCN Pull-Down Resistance	_	_	430	_	kΩ
R <sub>PL_SLP_G</sub>	DGCN Pull-Low Resistance in Sleep Mode	SLP = 1, resistance between DGCN and GND	_ 8		_	Ω
R <sub>PL_SLP_S</sub>	DSCN Pull-Low Resistance in Sleep Mode	SLP = 1, resistance between DSCN and GND	_	830	_	Ω
R <sub>PL_SLP_GS</sub>	DGCN to DSCN Pull-Low Resistance in Sleep Mode	SLP = 1, resistance between DGCN and DSCN	_	1.65	_	kΩ
R <sub>PL_STB_G</sub>	DGCN Pull-Low Resistance in Standby Mode	SLP = 0, V <sub>DCN</sub> = 0 V, resistance between DGCN and GND	_	50	_	Ω
R <sub>PL_STB_S</sub>	DSCN Pull-Low Resistance in Standby Mode	SLP = 0, V <sub>DCN</sub> = 0 V, resistance between DSCN and GND	_	50	_	Ω
R <sub>PL_STB_GS</sub>	DGCN to DSCN Pull-Low Resistance in Standby Mode	SLP = 0, V <sub>DCN</sub> = 0 V, resistance between DGCN and DSCN	_	90	_	Ω
R <sub>PL_S_0</sub>	DGN0 Pull-Low Resistance in Sleep and Standby Mode	V <sub>DN0</sub> = 0 V, SLP = 0 or 1, resistance between DGN0 and GND	_	5	_	Ω
R <sub>PL_S_1</sub>	DGN1 Pull-Low Resistance in Sleep and Standby Mode	V <sub>DN1</sub> = 0 V, SLP = 0 or 1, resistance between DGN1 and GND	_	8.5	_	Ω



# Accumulative Cell Voltage Monitor I<sup>2</sup>C Interface Electrical Characteristics

Table 30. Accumulative Cell Voltage Monitor I<sup>2</sup>C Interface Electrical Characteristics

 $V_{IN}$  = 36 V,  $T_A$  = 25 °C, unless otherwise specified

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
f <sub>SCL</sub>	Clock Frequency	_	_	_	400	kHz
t <sub>BMF</sub>	Bus Free Time	Bus free time between STOP and START	1.3	_	_	μs
t <sub>HD:STA</sub>	START Hold Time	After this period, the first clock pulse is generated	0.6	_	_	μs
$t_{LOW}$	SCL Low Time	_	1.3	_	_	μs
t <sub>HIGH</sub>	SCL High Time	_	0.6	_	_	μs
$t_{\text{SU:STA}}$	START Setup Time	Only relevant for Repeated START	0.6		_	μs
$t_{\text{HD:DAT}}$	Data Hold Time	_	0		_	ns
t <sub>SU:DAT</sub>	Data Setup Time	_	100		_	ns
t <sub>R_I2C</sub>	Rising Time	SDA and SCL (Note)			0.3	μs
t <sub>F_I2C</sub>	Falling Time	SDA and SCL (Note)	_		0.3	μs
t <sub>su:sto</sub>	STOP Setup Time	_	0.6	_	_	μs
t <sub>AA</sub>	Output Valid from Clock	_	_	_	0.9	μs
t <sub>SP</sub>	Input Filter Time Constant	SDA and SCL noise suppression time	_	_	20	ns
+	I <sup>2</sup> C Time Out	Trimming selection 1 (default setting)	_	32	_	ms
t <sub>out</sub>	T G Tillle Out	Trimming selection 2	_	64	_	ms

Note: These parameters are periodically sampled but not 100% tested.

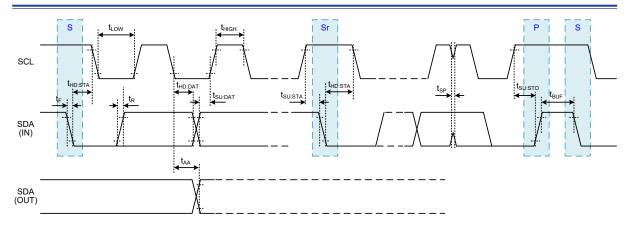


Figure 28. Accumulative Cell Voltage Monitor I<sup>2</sup>C Interface Timing Diagrams



### I<sup>2</sup>C Characteristics

Table 31. I<sup>2</sup>C Characteristics

Cumbal	Doromotor	Standard Mode		Fast Mode		Fast Plus Mode		Unit	
Symbol	Parameter	Min.	Max.	Min.	Max.	Min.	Max.	UIIIL	
f <sub>SCL</sub>	SCL Clock Frequency	_	100	_	400	_	1000	kHz	
t <sub>SCL(H)</sub>	SCL Clock High Time	4.5	_	1.125	_	0.45	_	μs	
t <sub>SCL(L)</sub>	SCL Clock Low Time	4.5	_	1.125	_	0.45	_	μs	
t <sub>FALL</sub>	SCL And SDA Fall Time	_	1.3	_	0.34	_	0.135	μs	
t <sub>RISE</sub>	SCL And SDA Rise Time	_	1.3		0.34	_	0.135	μs	
t <sub>SU(SDA)</sub>	SDA Data Setup Time	500	_	125	_	50	_	ns	
4	SDA Data Hold Time (Note 5)	0	_	0	_	0	_	ns	
$t_{H(SDA)}$	SDA Data Hold Time (Note 6)	100	_	100	_	100	_	ns	
t <sub>VD(SDA)</sub>	SDA Data Valid Time	_	1.6		0.475	_	0.25	μs	
t <sub>SU(STA)</sub>	START Condition Setup Time	500	_	125	_	50	_	ns	
t <sub>H(STA)</sub>	START Condition Hold Time	0	_	0	_	0	_	ns	
$t_{\text{SU(STO)}}$	STOP Condition Setup Time	500	_	125	_	50	_	ns	

Note: 1. Data based on characterization results only, not tested in production.

- 2. To achieve 100 kHz standard mode, the peripheral clock frequency must be higher than 2 MHz.
- 3. To achieve 400 kHz fast mode, the peripheral clock frequency must be higher than 8 MHz.
- 4. To achieve 1 MHz fast mode plus, the peripheral clock frequency must be higher than 20 MHz.
- 5. The above characteristic parameters of the  $I^2C$  bus timing are based on: COMBFILTEREN = 0 and SEQFILTER = 00.
- 6. The above characteristic parameters of the  $I^2C$  bus timing are based on: COMBFILTEREN = 1 and SEQFILTER = 00.

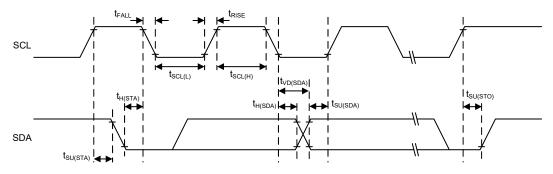


Figure 29. I<sup>2</sup>C Timing Diagrams



## **SPI Characteristics**

#### **Table 32. SPI Characteristics**

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit	
SPI Maste	Master Mode						
f <sub>SCK</sub>	SPI Master Output SCK Clock Frequency	Master mode SPI peripheral clock frequency f <sub>PCLK</sub>	ripheral clock — — —		f <sub>PCLK</sub> /2	MHz	
$t_{\text{SCK}(\text{H})} \\ t_{\text{SCK}(\text{L})}$	SCK Clock High and Low Time	_	t <sub>SCK</sub> /2 - 2	_	t <sub>SCK</sub> /2 + 1	ns	
$t_{\text{V(MO)}}$	Data Output Valid Time	_	_	_	5	ns	
t <sub>H(MO)</sub>	Data Output Hold Time	_	2	_	_	ns	
t <sub>SU(MI)</sub>	Data Input Setup Time	_	5	_	_	ns	
t <sub>H(MI)</sub>	Data Input Hold Time	_	5	_	_	ns	
SPI Slave	Mode						
f <sub>sck</sub>	SPI Slave Input SCK Clock Frequency	Slave mode SPI peripheral clock frequency f <sub>PCLK</sub>	_	_	f <sub>PCLK</sub> /3	MHz	
Duty <sub>SCK</sub>	SPI Slave Input SCK Clock Duty Cycle	_	30	_	70	%	
t <sub>SU(SEL)</sub>	SEL Enable Setup Time	_	3 t <sub>PCLK</sub>	_	_	ns	
t <sub>H(SEL)</sub>	SEL Enable Hold Time	_	2 t <sub>PCLK</sub>	_	_	ns	
t <sub>A(SO)</sub>	Data Output Access Time	_	_	_	3 t <sub>PCLK</sub>	ns	
t <sub>DIS(SO)</sub>	Data Output Disable Time	_	_		10	ns	
t <sub>V(SO)</sub>	Data Output Valid Time	_	_	_	25	ns	
t <sub>H(SO)</sub>	Data Output Hold Time	_	15	_	_	ns	
t <sub>SU(SI)</sub>	Data Input Setup Time	_	5	_	_	ns	
t <sub>H(SI)</sub>	Data Input Hold Time	_	4	_	_	ns	

Note: 1.  $f_{\text{SCK}}$  is SPI output/input clock frequency and  $t_{\text{SCK}}$ = 1/ $f_{\text{SCK}}$ .

<sup>2.</sup>  $f_{PCLK}$  is SPI peripheral clock frequency and  $t_{PCLK}$ = 1/ $f_{PCLK}$ .



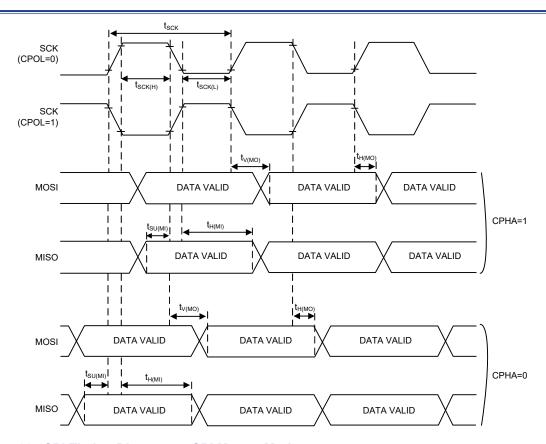


Figure 30. SPI Timing Diagrams - SPI Master Mode

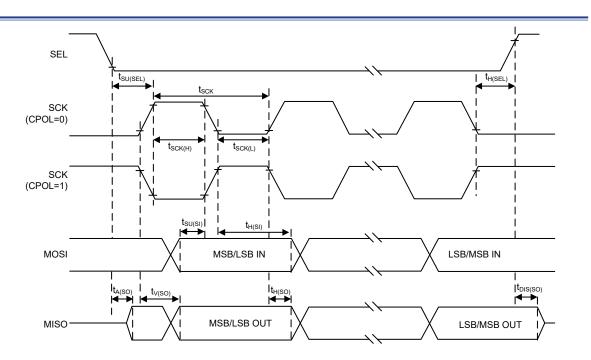


Figure 31. SPI Timing Diagrams - SPI Slave Mode with CPHA = 1



## **7** Package Information

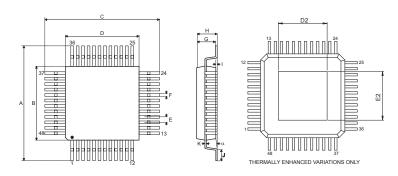
Note that the package information provided here is for consultation purposes only. As this information may be updated at regular intervals users are reminded to consult the <u>Holtek website</u> for the latest version of the <u>Package Information</u>.

Additional supplementary information with regard to packaging is listed below. Click on the relevant section to be transferred to the relevant website page.

- Package Information (include Outline Dimensions, Product Tape and Reel Specifications)
- The Operation Instruction of Packing Materials
- Carton information



## 48-pin LQFP-EP (7mm×7mm) Outline Dimensions



Symbol		Dimensions in inch	
Syllibol	Min.	Nom.	Max.
А	_	0.354 BSC	_
В	_	0.276 BSC	_
С	_	0.354 BSC	_
D	_	0.276 BSC	_
Е	_	0.020 BSC	_
D2	0.170	_	0.211
E2	0.170	_	0.211
F	0.007	0.009	0.011
G	0.053	0.055	0.057
Н	_	_	0.063
1	0.002	_	0.006
J	0.018	0.024	0.030
K	0.004	_	0.008
α	0°	_	7°

Cumbal		Dimensions in mm	
Symbol	Min.	Nom.	Max.
А	_	9.00 BSC	_
В	_	7.00 BSC	_
С	_	9.00 BSC	_
D	_	7.00 BSC	_
Е	_	0.50 BSC	_
D2	4.31	_	5.36
E2	4.31	_	5.36
F	0.17	0.22	0.27
G	1.35	1.40	1.45
Н	_	_	1.60
I	0.05	_	0.15
J	0.45	0.60	0.75
K	0.09	_	0.20
α	0°	_	7°



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